

## ADC081000 High Performance, Low Power 8-Bit, 1 GSPS A/D Converter

Check for Samples: [ADC081000](#)

### FEATURES

- Internal Sample-and-Hold
- Single +1.9V  $\pm 0.1$ V Operation
- Adjustable Output Levels
- Ensured No Missing Codes
- Low Power Standby Mode

### APPLICATIONS

- Direct RF Down Conversion
- Digital Oscilloscopes
- Satellite Set-top boxes
- Communications Systems
- Test Instrumentation

### APPLICATIONS

- Resolution 8 Bits
- Max Conversion Rate 1 GSPS (Min)
- ENOB at 500 MHz Input 7.5 Bits (Typ)
- DNL  $\pm 0.25$  LSB (Typ)
- Conversion Latency 7 and 8 Clock Cycles
- Power Consumption
  - Operating 1.45 W (Typ)
  - Power Down Mode 9 mW (Typ)

### DESCRIPTION

The ADC081000 is a low power, high performance CMOS analog-to-digital converter that digitizes signals to 8 bits resolution at sampling rates up to 1.6 GSPS. Consuming a typical 1.4 Watts at 1 GSPS from a single 1.9 Volt supply, this device is ensured to have no missing codes over the full operating temperature range. The unique folding and interpolating architecture, the fully differential comparator design, the innovative design of the internal sample-and-hold amplifier and the self-calibration scheme enable a very flat response of all dynamic parameters beyond Nyquist, producing a high 7.5 ENOB with a 500 MHz input signal and a 1 GHz sample rate while providing a  $10^{-18}$  B.E.R. Output formatting is offset binary and the LVDS digital outputs are compliant with IEEE 1596.3-1996, with the exception of a reduced common mode voltage of 0.8V.

The converter has a 1:2 demultiplexer that feeds two LVDS buses, reducing the output data rate on each bus to half the sampling rate. The data on these buses are interleaved in time to provide a 500 MHz output rate per bus and a combined output rate of 1 GSPS.

The converter typically consumes less than 10 mW in the Power Down Mode and is available in a 128-lead HLQFP and operates over the industrial ( $-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$ ) temperature range.



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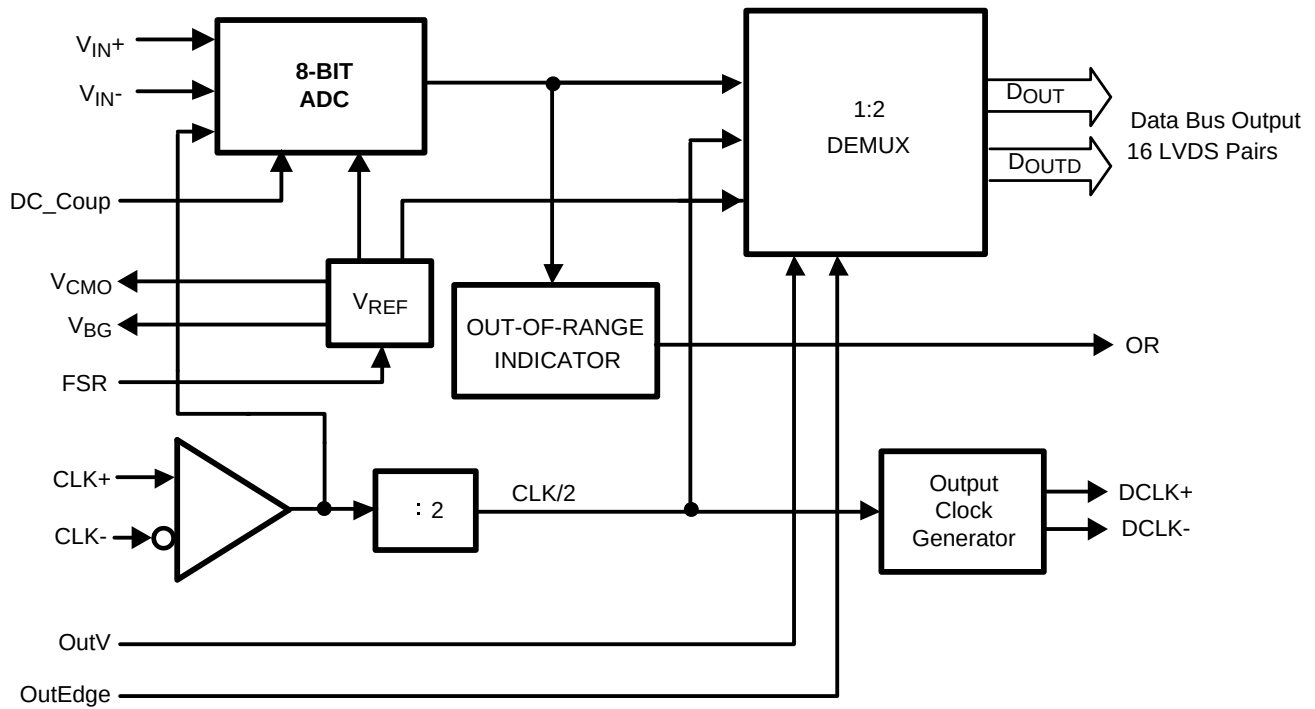
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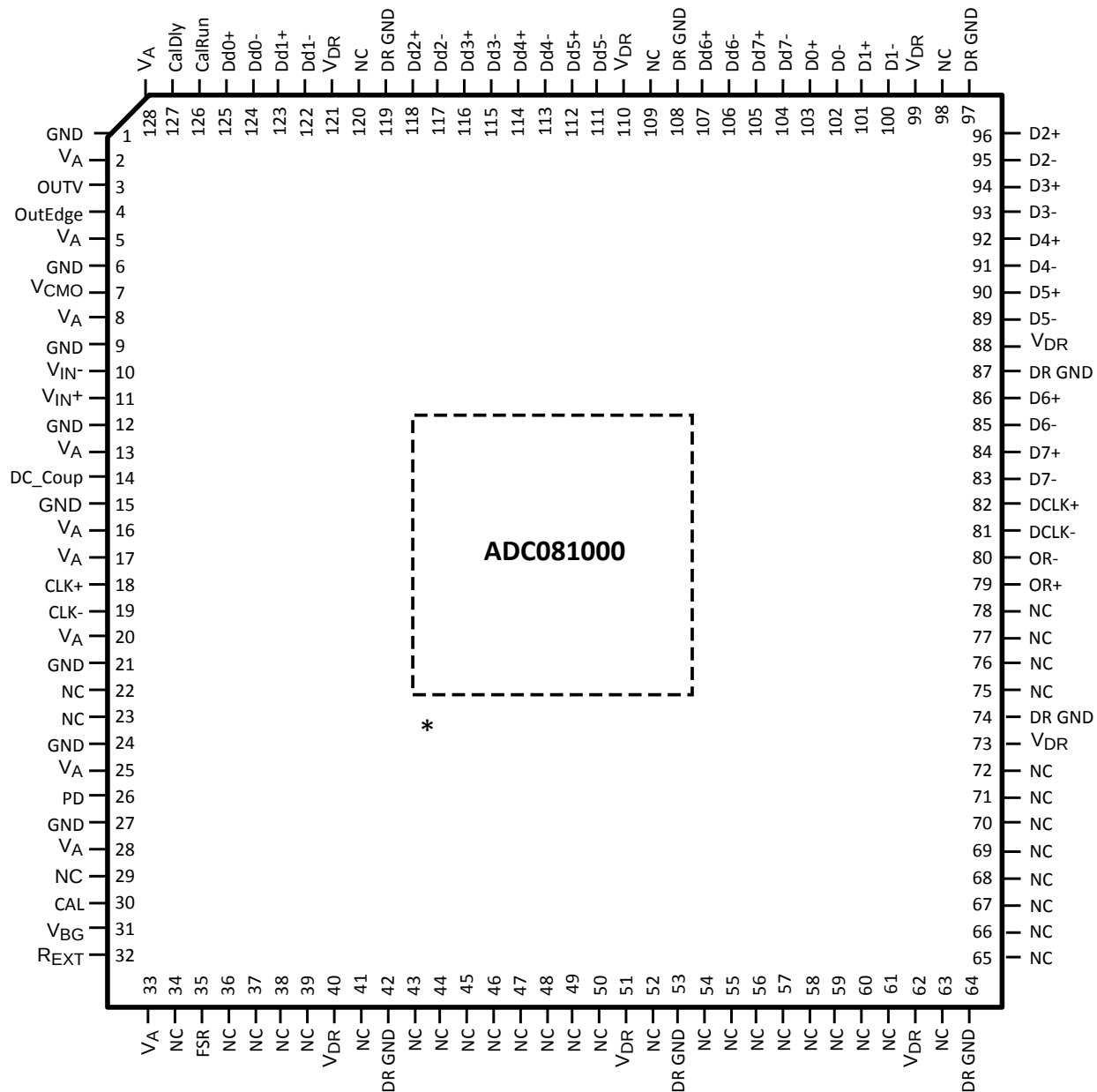


These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## Block Diagram



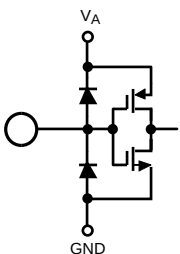
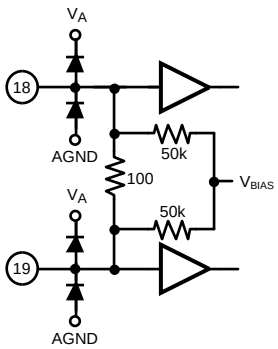
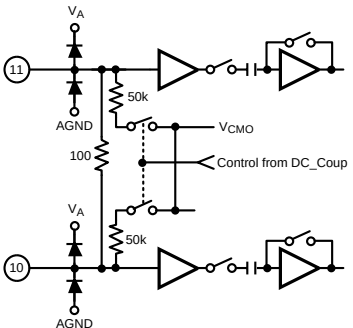
## PIN CONFIGURATION

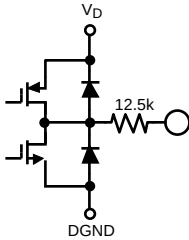
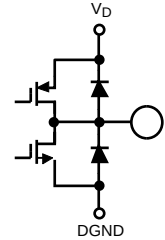
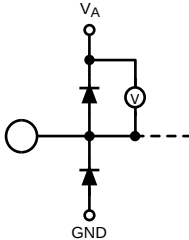


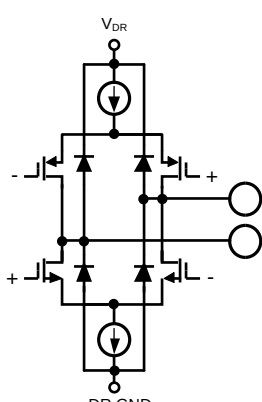
\* Exposed pad on back of package must be soldered to ground plane to ensure rated performance.

**Figure 1. 128-Lead HLQFP**  
See NNB0128A Package

## Pin Descriptions and Equivalent Circuits

| Pin Functions |                        |                                                                                     |                                                                                                                                                                                                                                                                                                                                                                           |
|---------------|------------------------|-------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Pin No.       | Symbol                 | Equivalent Circuit                                                                  | Description                                                                                                                                                                                                                                                                                                                                                               |
| 3             | OutV                   |    | Output Voltage Amplitude set. Tie this pin high for normal differential output amplitude. Ground this pin for a reduced differential output amplitude and reduced power consumption. See <a href="#">The LVDS Outputs</a> .                                                                                                                                               |
| 4             | OutEdge                |                                                                                     | Output Edge Select. Sets the edge of the DCLK+ (pin 82) at which the output data transitions. The output transitions with the DCLK+ rising edge when this pin is high or on the falling edge when this pin is low. See <a href="#">Output Edge Synchronization</a> .                                                                                                      |
| 14            | DC_Coup                |                                                                                     | DC Coupling select. When this pin is high, the $V_{IN+}$ and $V_{IN-}$ analog inputs are d.c. coupled and the input common mode voltage should equal the $V_{CMO}$ (pin 7) output voltage. When this pin is low, the analog input pins are internally biased and the input signal should be a.c. coupled to the analog input pins. See <a href="#">THE ANALOG INPUT</a> . |
| 26            | PD                     |                                                                                     | Power Down Pin. A logic high on this pin puts the ADC into the Power Down mode. A logic low on this pin allows normal operation.                                                                                                                                                                                                                                          |
| 30            | CAL                    |                                                                                     | Calibration. A minimum 10 clock cycles low followed by a minimum of 10 clock cycles high on this pin will initiate the self calibration sequence. See <a href="#">Self-Calibration</a> .                                                                                                                                                                                  |
| 35            | FSR                    |                                                                                     | Full scale Range Select. With a logic low on this pin, the full-scale differential input is 600 mV <sub>p-p</sub> . With a logic high on this pin, the full-scale differential input is 800 mV <sub>p-p</sub> . See <a href="#">The Analog Inputs</a> .                                                                                                                   |
| 127           | CalDly                 |                                                                                     | Calibration Delay. This sets the number of clock cycles after power up before calibration begins. See <a href="#">Self-Calibration</a> .                                                                                                                                                                                                                                  |
| 18<br>19      | CLK+<br>CLK–           |  | Clock input pins for the ADC. The differential clock signal must be a.c. coupled to these pins. The input signal is sampled on the falling edge of CLK+.                                                                                                                                                                                                                  |
| 11<br>10      | $V_{IN+}$<br>$V_{IN-}$ |  | Analog Signal Differential Inputs to the ADC.                                                                                                                                                                                                                                                                                                                             |

| Pin Functions |           |                                                                                    |                                                                                                                                                                                                                                                    |
|---------------|-----------|------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Pin No.       | Symbol    | Equivalent Circuit                                                                 | Description                                                                                                                                                                                                                                        |
| 7             | $V_{CMO}$ |   | Common Mode Output voltage for $V_{IN+}$ and $V_{IN-}$ when d.c. input coupling is used, in which case the voltage at this pin is required to be the common mode input voltage at $V_{IN+}$ and $V_{IN-}$ . See <a href="#">THE ANALOG INPUT</a> . |
| 31            | $V_{BG}$  |   | Bandgap output voltage. This pin is capable of sourcing or sinking up to 1.0 $\mu A$ .                                                                                                                                                             |
| 126           | CalRun    |                                                                                    | Calibration Running indication. This pin is at a logic high when calibration is running.                                                                                                                                                           |
| 32            | $R_{EXT}$ |  | External Bias Resistor connection. The required value is 3.3k-Ohms ( $\pm 0.1\%$ ) to ground. See <a href="#">Self-Calibration</a> .                                                                                                               |

| Pin Functions                                                                                                |                                                                                                                              |                                                                                   |                                                                                                                                                                                                                                      |
|--------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Pin No.                                                                                                      | Symbol                                                                                                                       | Equivalent Circuit                                                                | Description                                                                                                                                                                                                                          |
| 83<br>84<br>85<br>86<br>89<br>90<br>91<br>92<br>93<br>94<br>95<br>96<br>100<br>101<br>102<br>103             | D7-<br>D7+<br>D6-<br>D6+<br>D5-<br>D5+<br>D4-<br>D4+<br>D3-<br>D3+<br>D2-<br>D2+<br>D1-<br>D1+<br>D0-<br>D0+                 |  | LVDS data output bits sampled second in time sequence. These outputs should always be terminated with a differential 100Ω resistance.                                                                                                |
| 104<br>105<br>106<br>107<br>111<br>112<br>113<br>114<br>115<br>116<br>117<br>118<br>122<br>123<br>124<br>125 | Dd7-<br>Dd7+<br>Dd6-<br>Dd6+<br>Dd5-<br>Dd5+<br>Dd4-<br>Dd4+<br>Dd3-<br>Dd3+<br>Dd2-<br>Dd2+<br>Dd1-<br>Dd1+<br>Dd0-<br>Dd0+ |                                                                                   | LVDS data output bits sampled first in time sequence. These outputs should always be terminated with a differential 100Ω resistance.                                                                                                 |
| 79<br>80                                                                                                     | OR+<br>OR-                                                                                                                   |                                                                                   | Out of Range output. A differential high at these pins indicates that the differential input is out of range (outside the range of ±300 mV or ±400 mV as defined by the FSR pin). See <a href="#">Out Of Range (OR) Indication</a> . |
| 82<br>81                                                                                                     | DCLK+<br>DCLK-                                                                                                               |                                                                                   | Differential Clock Outputs used to latch the output data. Delayed and non-delayed data outputs are supplied synchronous to this signal.                                                                                              |
| 2, 5, 8, 13, 16,<br>17, 20, 25, 28,<br>33, 128                                                               | V <sub>A</sub>                                                                                                               |                                                                                   | Analog power supply pins. Bypass these pins to GND.                                                                                                                                                                                  |
| 40, 51, 62, 73,<br>88, 99, 110, 121                                                                          | V <sub>DR</sub>                                                                                                              |                                                                                   | Output Driver power supply pins. Bypass these pins to DR GND.                                                                                                                                                                        |
| 1, 6, 9, 12, 15,<br>21, 24, 27                                                                               | GND                                                                                                                          |                                                                                   | Ground return for V <sub>A</sub>                                                                                                                                                                                                     |
| 42, 53, 64, 74,<br>87, 97, 108, 119                                                                          | DR GND                                                                                                                       |                                                                                   | Ground return for V <sub>DR</sub>                                                                                                                                                                                                    |
| 22, 23, 29, 34,<br>36–39, 41,<br>43–50, 52,<br>54–61, 63,<br>65–72, 75–78,<br>98, 109, 120                   | NC                                                                                                                           |                                                                                   | No Connection. Make no connection to these pins.                                                                                                                                                                                     |

## ABSOLUTE MAXIMUM RATINGS<sup>(1)(2)</sup>

|                                                            |                  |                             |
|------------------------------------------------------------|------------------|-----------------------------|
| Analog Supply Voltage ( $V_A$ , $V_{DR}$ )                 |                  | 2.2V                        |
| Digital Supply above Analog Supply ( $V_{DR} - V_A$ )      |                  | 300 mV                      |
| Voltage on Any Input Pin (Except $V_{IN+}$ , $V_{IN-}$ )   |                  | -0.15V to ( $V_A + 0.15V$ ) |
| Voltage on $V_{IN+}$ , $V_{IN-}$ (Maintaining Common Mode) |                  | -0.15V to 2.5V              |
| Ground Difference: $ GND - DR\ GND $                       |                  | 0V to 100 mV                |
| Input Current at Any Pin <sup>(3)</sup>                    |                  | $\pm 25$ mA                 |
| Package Input Current <sup>(3)</sup>                       |                  | $\pm 50$ mA                 |
| Power Dissipation at $T_A = 25^\circ\text{C}$              |                  | 2.0 W                       |
| ESD Susceptibility <sup>(4)</sup>                          | Human Body Model | 2500V                       |
|                                                            | Machine Model    | 250V                        |
| Soldering Temperature, Infrared, 10 seconds <sup>(5)</sup> |                  | 235°C                       |
| Storage Temperature                                        |                  | -65°C to +150°C             |

- (1) All voltages are measured with respect to  $GND = DR\ GND = 0V$ , unless otherwise specified.
- (2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. There is **no** ensurance of operation at the Absolute Maximum Ratings. Operating Ratings indicate conditions for which the device is functional, but do **not** ensure specific performance limits. For specifications and test conditions, see the Electrical Characteristics. The specified specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.
- (3) When the input voltage at any pin exceeds the power supply limits (that is, less than  $GND$  or greater than  $V_A$ ), the current at that pin should be limited to 25 mA. The 50 mA maximum package input current rating limits the number of pins that can safely exceed the power supplies with an input current of 25 mA to two. This limit is not placed upon the power, ground and digital output pins.
- (4) Human body model is 100 pF capacitor discharged through a 1.5 k $\Omega$  resistor. Machine model is 220 pF discharged through ZERO Ohms.
- (5) See <http://www.ti.com> for methods of soldering surface mount devices.

## OPERATING RATINGS<sup>(1)(2)</sup>

|                                                               |                                                     |
|---------------------------------------------------------------|-----------------------------------------------------|
| Ambient Temperature Range                                     | $-40^\circ\text{C} \leq T_A \leq +85^\circ\text{C}$ |
| Supply Voltage ( $V_A$ )                                      | +1.8V to +2.0V                                      |
| Driver Supply Voltage ( $V_{DR}$ )                            | +1.8V to $V_A$                                      |
| Analog Input Common Mode Voltage                              | 1.2V to 1.3V                                        |
| $V_{IN+}$ , $V_{IN-}$ Voltage Range (Maintaining Common Mode) | 0V to 2.15V (100% duty cycle)                       |
|                                                               | 0V to 2.5V (10% duty cycle)                         |
| Ground Difference ( $ GND - DR\ GND $ )                       | 0V                                                  |
| CLK Pins Voltage Range                                        | 0V to $V_A$                                         |
| Differential CLK Amplitude                                    | 0.6V <sub>P-P</sub> to 2.0V <sub>P-P</sub>          |

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. There is **no** ensurance of operation at the Absolute Maximum Ratings. Operating Ratings indicate conditions for which the device is functional, but do **not** ensure specific performance limits. For specifications and test conditions, see the Electrical Characteristics. The specified specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.
- (2) All voltages are measured with respect to  $GND = DR\ GND = 0V$ , unless otherwise specified.

## PACKAGE THERMAL RESISTANCES<sup>(1)</sup>

| Package        | $\theta_{J-C}$ (Top of Package) | $\theta_{J-PAD}$ (Thermal Pad) |
|----------------|---------------------------------|--------------------------------|
| 128-Lead HLQFP | 10°C / W                        | 2.8°C / W                      |

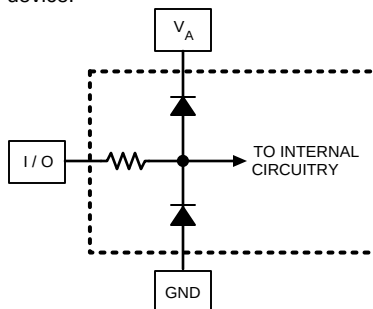
- (1) Soldering process must comply with Reflow Temperature Profile specifications. Refer to [www.ti.com/packaging](http://www.ti.com/packaging).

## CONVERTER ELECTRICAL CHARACTERISTICS

The following specifications apply after calibration for  $V_A = V_{DR} = +1.9V_{DC}$ ,  $OutV = 1.9V$ ,  $V_{IN}$  FSR (a.c. coupled) = differential 800mV<sub>P-P</sub>,  $C_L = 10$  pF, Differential, a.c. coupled Sinewave Clock,  $f_{CLK} = 1$  GHz at 0.5V<sub>P-P</sub> with 50% duty cycle,  $R_{EXT} = 330\Omega \pm 0.1\%$ , Analog Signal Source Impedance = 100 $\Omega$ . **Boldface limits apply for  $T_A = T_{MIN}$  to  $T_{MAX}$ .** All other limits  $T_A = 25^\circ C$ , unless otherwise stated<sup>(1)(2)(3)</sup>

| Symbol                                   | Parameter                                | Conditions                                  | Typical <sup>(4)</sup> | Limits <sup>(4)</sup>       | Units (Limits)         |
|------------------------------------------|------------------------------------------|---------------------------------------------|------------------------|-----------------------------|------------------------|
| <b>STATIC CONVERTER CHARACTERISTICS</b>  |                                          |                                             |                        |                             |                        |
| INL                                      | Integral Non-Linearity                   |                                             | $\pm 0.35$             | <b><math>\pm 0.9</math></b> | LSB (max)              |
| DNL                                      | Differential Non-Linearity               |                                             | $\pm 0.25$             | <b><math>\pm 0.7</math></b> | LSB (max)              |
|                                          | Resolution with No Missing Codes         |                                             |                        | <b>8</b>                    | Bits                   |
| $V_{OFF}$                                | Offset Error                             |                                             | -0.45                  | <b>-1.5</b><br><b>0.5</b>   | LSB (min)<br>LSB (max) |
| TC $V_{OFF}$                             | Offset Error Tempco                      | -40°C to +85°C                              | -3                     |                             | ppm/°C                 |
| PFSE                                     | Positive Full-Scale Error <sup>(5)</sup> |                                             | -2.2                   | <b><math>\pm 25</math></b>  | mV (max)               |
| NFSE                                     | Negative Full-Scale Error <sup>(5)</sup> |                                             | -1.1                   | <b><math>\pm 25</math></b>  | mV (max)               |
| TC PFSE                                  | Positive Full Scale Error Tempco         | -40°C to +85°C                              | 20                     |                             | ppm/°C                 |
| TC NFSE                                  | Negative Full Scale Error Tempco         | -40°C to +85°C                              | 13                     |                             | ppm/°C                 |
| <b>Dynamic Converter Characteristics</b> |                                          |                                             |                        |                             |                        |
| FPBW                                     | Full Power Bandwidth                     |                                             | 1.7                    |                             | GHz                    |
| B.E.R.                                   | Bit Error Rate                           |                                             | $10^{-18}$             |                             | Error/Bit              |
|                                          | Gain Flatness                            | d.c. to 500 MHz                             | $\pm 0.5$              |                             | dBFS                   |
|                                          |                                          | d.c. to 1 GHz                               | $\pm 1.0$              |                             | dBFS                   |
| ENOB                                     | Effective Number of Bits                 | $f_{IN} = 100$ MHz, $V_{IN} = FSR - 0.5$ dB | 7.5                    |                             | Bits                   |
|                                          |                                          | $f_{IN} = 248$ MHz, $V_{IN} = FSR - 0.5$ dB | 7.5                    | <b>7.1</b>                  | Bits (min)             |
|                                          |                                          | $f_{IN} = 498$ MHz, $V_{IN} = FSR - 0.5$ dB | 7.5                    | <b>7.1</b>                  | Bits (min)             |
| SINAD                                    | Signal-to-Noise Plus Distortion Ratio    | $f_{IN} = 100$ MHz, $V_{IN} = FSR - 0.5$ dB | 47                     |                             | dB                     |
|                                          |                                          | $f_{IN} = 248$ MHz, $V_{IN} = FSR - 0.5$ dB | 47                     | <b>44.8</b>                 | dB (min)               |
|                                          |                                          | $f_{IN} = 498$ MHz, $V_{IN} = FSR - 0.5$ dB | 47                     | <b>44.8</b>                 | dB (min)               |
| SNR                                      | Signal-to-Noise Ratio                    | $f_{IN} = 100$ MHz, $V_{IN} = FSR - 0.5$ dB | 48                     |                             | dB                     |
|                                          |                                          | $f_{IN} = 248$ MHz, $V_{IN} = FSR - 0.5$ dB | 48                     | <b>45.5</b>                 | dB (min)               |
|                                          |                                          | $f_{IN} = 498$ MHz, $V_{IN} = FSR - 0.5$ dB | 48                     | <b>45.5</b>                 | dB (min)               |

- (1) The analog inputs are protected as shown below. Input voltage magnitudes beyond the Absolute Maximum Ratings may damage this device.



- (2) To ensure accuracy, it is required that  $V_A$  and  $V_{DR}$  be well bypassed. Each supply pin must be decoupled with separate bypass capacitors. Additionally, achieving rated performance requires that the backside exposed pad be well grounded.
- (3) The ADC081000 has two interleaved LVDS output buses, which each clock data out at one half the sample rate. The data at each bus is clocked out at one half the sample rate. The second bus (D0 through D7) has a pipeline latency that is one clock cycle less than the latency of the first bus (Dd0 through Dd7).
- (4) Typical figures are at  $T_J = 25^\circ C$ , and represent most likely parametric norms. Test limits are ensured to AOQL (Average Outgoing Quality Level).
- (5) Calculation of Full-Scale Error for this device assumes that the actual reference voltage is exactly its nominal value. Full-Scale Error for this device, therefore, is a combination of Full-Scale Error and Reference Voltage Error. See Transfer Characteristic [Figure 2](#). For relationship between Gain Error and Full-Scale Error, see Specification Definitions for Gain Error.

## CONVERTER ELECTRICAL CHARACTERISTICS (continued)

The following specifications apply after calibration for  $V_A = V_{DR} = +1.9V_{DC}$ ,  $OutV = 1.9V$ ,  $V_{IN}$  FSR (a.c. coupled) = differential 800mV<sub>P-P</sub>,  $C_L = 10$  pF, Differential, a.c. coupled Sinewave Clock,  $f_{CLK} = 1$  GHz at 0.5V<sub>P-P</sub> with 50% duty cycle,  $R_{EXT} = 3300\Omega \pm 0.1\%$ , Analog Signal Source Impedance = 100 $\Omega$ . **Boldface limits apply for  $T_A = T_{MIN}$  to  $T_{MAX}$ .** All other limits  $T_A = 25^\circ C$ , unless otherwise stated<sup>(1)(2)(3)</sup>

| Symbol                                     | Parameter                                                   | Conditions                                                                                                           | Typical <sup>(4)</sup> | Limits <sup>(4)</sup>                                     | Units<br>(Limits)       |
|--------------------------------------------|-------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------|------------------------|-----------------------------------------------------------|-------------------------|
| THD                                        | Total Harmonic Distortion                                   | f <sub>IN</sub> = 100 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | -57                    |                                                           | dB                      |
|                                            |                                                             | f <sub>IN</sub> = 248 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | -57                    | <b>–50</b>                                                | dB (max)                |
|                                            |                                                             | f <sub>IN</sub> = 498 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | -57                    | <b>–50</b>                                                | dB (max)                |
| 2nd Harm                                   | Second Harmonic Distortion                                  | f <sub>IN</sub> = 100 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | –64                    |                                                           | dB                      |
|                                            |                                                             | f <sub>IN</sub> = 248 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | –64                    |                                                           | dB                      |
|                                            |                                                             | f <sub>IN</sub> = 498 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | –64                    |                                                           | dB                      |
| 3rd Harm                                   | Third Harmonic Distortion                                   | f <sub>IN</sub> = 100 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | –64                    |                                                           | dB                      |
|                                            |                                                             | f <sub>IN</sub> = 248 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | –64                    |                                                           | dB                      |
|                                            |                                                             | f <sub>IN</sub> = 498 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | –64                    |                                                           | dB                      |
| SFDR                                       | Spurious-Free dynamic Range                                 | f <sub>IN</sub> = 100 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | 58.5                   |                                                           | dB                      |
|                                            |                                                             | f <sub>IN</sub> = 248 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | 58.5                   | <b>50</b>                                                 | dB (min)                |
|                                            |                                                             | f <sub>IN</sub> = 498 MHz, V <sub>IN</sub> = FSR – 0.5 dB                                                            | 58.5                   | <b>50</b>                                                 | dB (min)                |
| IMD                                        | Intermodulation Distortion                                  | f <sub>IN1</sub> = 121 MHz, V <sub>IN</sub> = FSR – 7 dB<br>f <sub>IN2</sub> = 126 MHz, V <sub>IN</sub> = FSR – 7 dB | -51                    |                                                           | dB                      |
|                                            | Out of Range Output Code<br>(In addition to OR Output high) | (V <sub>IN+</sub> ) – (V <sub>IN–</sub> ) > + Full Scale                                                             |                        | <b>255</b>                                                |                         |
|                                            |                                                             | (V <sub>IN+</sub> ) – (V <sub>IN–</sub> ) < – Full Scale                                                             |                        | <b>0</b>                                                  |                         |
| ANALOG INPUT AND REFERENCE CHARACTERISTICS |                                                             |                                                                                                                      |                        |                                                           |                         |
| V <sub>IN</sub>                            | Full Scale Analog Differential Input Range                  | FSR pin Low                                                                                                          | 600                    | <b>550</b>                                                | mV <sub>P-P</sub> (min) |
|                                            |                                                             |                                                                                                                      |                        | <b>650</b>                                                | mV <sub>P-P</sub> (max) |
|                                            |                                                             | FSR pin High                                                                                                         | 800                    | <b>750</b>                                                | mV <sub>P-P</sub> (min) |
|                                            |                                                             |                                                                                                                      |                        | <b>850</b>                                                | mV <sub>P-P</sub> (max) |
| V <sub>CM1</sub>                           | Common Mode Analog Input Voltage                            |                                                                                                                      | V <sub>CMO</sub>       | <b>V<sub>CMO</sub> – 50</b><br><b>V<sub>CMO</sub>+ 50</b> | mV (min)<br>mV (max)    |
| C <sub>IN</sub>                            | Analog Input Capacitance <sup>(6)</sup>                     | Differential                                                                                                         | 0.02                   |                                                           | pF                      |
|                                            |                                                             | Each input to ground                                                                                                 | 1.6                    |                                                           | pF                      |
| R <sub>IN</sub>                            | Differential Input Resistance                               |                                                                                                                      | 100                    | <b>94</b>                                                 | Ω (min)                 |
|                                            |                                                             |                                                                                                                      |                        | <b>106</b>                                                | Ω (max)                 |
| ANALOG OUTPUT CHARACTERISTICS              |                                                             |                                                                                                                      |                        |                                                           |                         |
| V <sub>CMO</sub>                           | Common Mode Output Voltage                                  | I <sub>CMO</sub> = ±1 μA                                                                                             | 1.21                   | <b>0.95</b><br><b>1.45</b>                                | V (min)<br>V (max)      |
| TC V <sub>CMO</sub>                        | Common Mode Output Voltage Temperature Coefficient          | T <sub>A</sub> = –40°C to +85°C                                                                                      | 118                    |                                                           | ppm/°C                  |
| V <sub>BG</sub>                            | Bandgap Reference Output Voltage                            | I <sub>BG</sub> = ±100 μA                                                                                            | 1.26                   | <b>1.22</b><br><b>1.33</b>                                | V (min)<br>V (max)      |
| TC V <sub>BG</sub>                         | Bandgap Reference Voltage Temperature Coefficient           | T <sub>A</sub> = –40°C to +85°C,<br>I <sub>BG</sub> = ±100 μA                                                        | -28                    |                                                           | ppm/°C                  |

(6) The analog and clock input capacitances are die capacitances only. Additional package capacitances of 0.65 pF differential and 0.95 pF each pin to ground are isolated from the die capacitances by lead and bond wire inductances.

## CONVERTER ELECTRICAL CHARACTERISTICS (continued)

The following specifications apply after calibration for  $V_A = V_{DR} = +1.9V_{DC}$ ,  $OutV = 1.9V$ ,  $V_{IN}$  FSR (a.c. coupled) = differential 800mV<sub>P-P</sub>,  $C_L = 10$  pF, Differential, a.c. coupled Sinewave Clock,  $f_{CLK} = 1$  GHz at 0.5V<sub>P-P</sub> with 50% duty cycle,  $R_{EXT} = 3300\Omega \pm 0.1\%$ , Analog Signal Source Impedance = 100 $\Omega$ . **Boldface limits apply for  $T_A = T_{MIN}$  to  $T_{MAX}$ .** All other limits  $T_A = 25^\circ C$ , unless otherwise stated<sup>(1)(2)(3)</sup>

| Symbol                              | Parameter                                         | Conditions                                                             | Typical <sup>(4)</sup> | Limits <sup>(4)</sup>    | Units<br>(Limits)                                |
|-------------------------------------|---------------------------------------------------|------------------------------------------------------------------------|------------------------|--------------------------|--------------------------------------------------|
| CLOCK INPUT CHARACTERISTICS         |                                                   |                                                                        |                        |                          |                                                  |
| V <sub>ID</sub>                     | Differential Clock Input Level                    | Square Wave Clock                                                      | 0.6                    | <b>0.4</b><br><b>2.0</b> | V <sub>P-P</sub> (min)<br>V <sub>P-P</sub> (max) |
|                                     |                                                   | Sine Wave Clock                                                        | 0.6                    | <b>0.4</b><br><b>2.0</b> | V <sub>P-P</sub> (min)<br>V <sub>P-P</sub> (max) |
| I <sub>I</sub>                      | Input Current                                     | V <sub>IN</sub> = 0V or V <sub>IN</sub> = V <sub>A</sub>               | ±1                     |                          | µA                                               |
| C <sub>IN</sub>                     | Input Capacitance <sup>(7)</sup>                  | Differential                                                           | 0.02                   |                          | pF                                               |
|                                     |                                                   | Each Input to Ground                                                   | 1.5                    |                          | pF                                               |
| DIGITAL CONTROL PIN CHARACTERISTICS |                                                   |                                                                        |                        |                          |                                                  |
| V <sub>IH</sub>                     | Logic High Input Voltage                          | See <sup>(8)</sup>                                                     |                        | <b>1.4</b>               | V (min)                                          |
| V <sub>IL</sub>                     | Logic Low Input Voltage                           | See <sup>(8)</sup>                                                     |                        | <b>0.5</b>               | V (max)                                          |
| I <sub>I</sub>                      | Input Current                                     | V <sub>IN</sub> = 0 or V <sub>IN</sub> = V <sub>A</sub>                | ±1                     |                          | µA                                               |
| C <sub>IN</sub>                     | Logic Input Capacitance <sup>(9)</sup>            | Each input to ground                                                   | 1.2                    |                          | pF                                               |
| DIGITAL OUTPUT CHARACTERISTICS      |                                                   |                                                                        |                        |                          |                                                  |
| V <sub>OD</sub>                     | LVDS Differential Output Voltage                  | OutV = V <sub>A</sub> , measured single-ended                          | 300                    | <b>200</b>               | mV <sub>P-P</sub> (min)                          |
|                                     |                                                   |                                                                        |                        | <b>450</b>               | mV <sub>P-P</sub> (max)                          |
|                                     |                                                   | OutV = GND, measured single-ended                                      | 225                    | <b>140</b>               | mV <sub>P-P</sub> (min)                          |
|                                     |                                                   |                                                                        |                        | <b>340</b>               | mV <sub>P-P</sub> (max)                          |
| Δ V <sub>OD DIFF</sub>              | Change in LVDS Output Swing Between Logic Levels  |                                                                        | ±1                     |                          | mV                                               |
| V <sub>OS</sub>                     | Output Offset Voltage                             |                                                                        | 800                    |                          | mV                                               |
| Δ V <sub>OS</sub>                   | Output Offset Voltage Change Between Logic Levels |                                                                        | ±1                     |                          | mV                                               |
| I <sub>OS</sub>                     | Output Short Circuit Current                      | Output+ & Output- connected to 0.8V                                    | −4                     |                          | mA                                               |
| Z <sub>O</sub>                      | Differential Output Impedance                     |                                                                        | 100                    |                          | Ohms                                             |
| POWER SUPPLY CHARACTERISTICS        |                                                   |                                                                        |                        |                          |                                                  |
| I <sub>A</sub>                      | Analog Supply Current                             | PD = Low<br>PD = High                                                  | 646<br>4.5             | <b>792</b>               | mA (max)<br>mA                                   |
| I <sub>DR</sub>                     | Output Driver Supply Current                      | PD = Low                                                               | 108                    | <b>160</b>               | mA (max)                                         |
|                                     |                                                   | PD = High                                                              | 0.1                    |                          | mA                                               |
| P <sub>D</sub>                      | Power Consumption                                 | PD = Low                                                               | 1.43                   | <b>1.8</b>               | W (max)                                          |
|                                     |                                                   | PD = High                                                              | 8.7                    |                          | mW                                               |
| PSRR1                               | D.C. Power Supply Rejection Ratio                 | Change in Offset Error with change in V <sub>A</sub> from 1.8V to 2.0V | 73                     |                          | dB                                               |
| AC ELECTRICAL CHARACTERISTICS       |                                                   |                                                                        |                        |                          |                                                  |
| f <sub>CLK1</sub>                   | Maximum Conversion Rate                           | T <sub>A</sub> = 85°C                                                  | 1.1                    | <b>1.0</b>               | GHz (min)                                        |
|                                     |                                                   | T <sub>A</sub> ≤ 75°C                                                  | 1.3                    |                          | GHz                                              |
|                                     |                                                   | T <sub>A</sub> ≤ 70°C                                                  | 1.6                    |                          | GHz                                              |
| f <sub>CLK2</sub>                   | Minimum Conversion Rate                           |                                                                        | 200                    |                          | MHz                                              |
|                                     | Input Clock Duty Cycle                            | 200 MHz ≤ Input clock frequency < 1 GHz                                | 50                     | 20<br>80                 | % (min)<br>% (max)                               |
| t <sub>CL</sub>                     | Input Clock Low Time <sup>(8)</sup>               |                                                                        | 500                    | <b>200</b>               | ps (min)                                         |

(7) The analog and clock input capacitances are die capacitances only. Additional package capacitances of 0.65 pF differential and 0.95 pF each pin to ground are isolated from the die capacitances by lead and bond wire inductances.

(8) This parameter is specified by design and characterization and is not tested in production.

(9) The digital control pin capacitances are die capacitances only. Additional package capacitance of 1.6 pF each pin to ground are isolated from the die capacitances by lead and bond wire inductances.

## CONVERTER ELECTRICAL CHARACTERISTICS (continued)

The following specifications apply after calibration for  $V_A = V_{DR} = +1.9V_{DC}$ ,  $OutV = 1.9V$ ,  $V_{IN}$  FSR (a.c. coupled) = differential 800mV<sub>P-P</sub>,  $C_L = 10$  pF, Differential, a.c. coupled Sinewave Clock,  $f_{CLK} = 1$  GHz at 0.5V<sub>P-P</sub> with 50% duty cycle,  $R_{EXT} = 3300\Omega \pm 0.1\%$ , Analog Signal Source Impedance = 100 $\Omega$ . **Boldface limits apply for  $T_A = T_{MIN}$  to  $T_{MAX}$ .** All other limits  $T_A = 25^\circ C$ , unless otherwise stated<sup>(1)(2)(3)</sup>

| Symbol    | Parameter                                          | Conditions                                              | Typical <sup>(4)</sup> | Limits <sup>(4)</sup>       | Units (Limits)     |
|-----------|----------------------------------------------------|---------------------------------------------------------|------------------------|-----------------------------|--------------------|
| $t_{CH}$  | Input Clock High Time <sup>(8)</sup>               |                                                         | 500                    | <b>200</b>                  | ps (min)           |
|           | DCLK Duty Cycle <sup>(8)</sup>                     |                                                         | 50                     | <b>45</b><br><b>55</b>      | % (min)<br>% (max) |
| $t_{LHT}$ | Differential Low to High Transition Time           | 10% to 90%, $C_L = 2.5$ pF                              | 250                    |                             | ps                 |
| $t_{HLT}$ | Differential High to Low Transition Time           | 10% to 90%, $C_L = 2.5$ pF                              | 250                    |                             | ps                 |
| $t_{OSK}$ | DCLK to Data Output Skew <sup>(10)</sup>           | 50% of DCLK transition to 50% of Data transition        | 0                      | <b><math>\pm 200</math></b> | ps (max)           |
| $t_{AD}$  | Sampling (Aperture) Delay                          | Input CLK+ Fall to Acquisition of Data                  | 930                    |                             | ps                 |
| $t_{AJ}$  | Aperture Jitter                                    |                                                         | 0.4                    |                             | ps rms             |
| $t_{OD}$  | Input Clock to Data Output Delay                   | 50% of Input Clock transition to 50% of Data transition | 2.7                    |                             | ns                 |
|           | Pipeline Delay (Latency) <sup>(10)</sup>           | "D" Outputs                                             |                        | <b>7</b>                    | Clock Cycles       |
|           |                                                    | "Dd" Outputs                                            |                        | <b>8</b>                    |                    |
| $t_{WU}$  | PD low to Rated Accuracy Conversion (Wake-Up Time) |                                                         | 500                    |                             | ns                 |
| $t_{CAL}$ | Calibration Cycle Time                             |                                                         | 46,000                 |                             | Clock Cycles       |

(10) This parameter is specified by design and is not tested in production.

## Specification Definitions

**APERTURE (SAMPLING) DELAY** is that time required after the fall of the clock input for the sampling switch to open. The Sample/Hold circuit effectively stops capturing the input signal and goes into the “hold” mode the aperture delay time ( $t_{AD}$ ) after the clock goes low.

**APERTURE JITTER ( $t_{AJ}$ )** is the variation in aperture delay from sample to sample. Aperture jitter shows up as input noise.

**Bit Error Rate (B.E.R.)** is the probability of error and is defined as the probable number of errors per unit of time divided by the number of bits seen in that amount of time. A B.E.R. of 10<sup>-18</sup> corresponds to a statistical error in one bit about every four (4) years.

**CLOCK DUTY CYCLE** is the ratio of the time that the clock wave form is at a logic high to the total time of one clock period.

**COMMON MODE VOLTAGE** is the d.c. potential that is common to both pins of a differential pair. For a voltage to be a common mode one, the signal departure from this d.c. common mode voltage at any given instant must be the same for each of the pins, but in opposite directions from each other.

**DIFFERENTIAL NON-LINEARITY (DNL)** is the measure of the maximum deviation from the ideal step size of 1 LSB. Measured at 1 GSPS with a ramp input.

**EFFECTIVE NUMBER OF BITS (ENOB, or EFFECTIVE BITS)** is another method of specifying Signal-to-Noise and Distortion Ratio, or SINAD. ENOB is defined as  $(\text{SINAD} - 1.76) / 6.02$  and says that the converter is equivalent to a perfect ADC of this (ENOB) number of bits.

**FULL POWER BANDWIDTH (FPBW)** is a measure of the frequency at which the reconstructed output fundamental drops 3 dB below its low frequency value for a full scale input.

**GAIN ERROR** is the deviation from the ideal slope of the transfer function. It can be calculated from Offset and Full-Scale Errors:

- $\text{PGE} = \text{OE} - \text{PFSE}$
- $\text{NGE} = -(\text{OE} - \text{NFSE}) = \text{NFSE} - \text{OE}$
- $\text{Gain Error} = \text{NFSE} - \text{PFSE} = \text{PGE} + \text{NGE}$

where PGE is Positive Gain Error, NGE is Negative Gain Error, OE is Offset Error, PFSE is Positive Full-Scale Error and NFSE is Negative Full-Scale Error.

**INTEGRAL NON-LINEARITY (INL)** is a measure of the deviation of each individual code from a straight line through the input to output transfer function. The deviation of any given code from this straight line is measured from the center of that code value. The best fit method is used.

**INTERMODULATION DISTORTION (IMD)** is the creation of additional spectral components as a result of two sinusoidal frequencies being applied to the ADC input at the same time. it is defined as the ratio of the power in the second and third order intermodulation products to the power in one of the original frequencies. IMD is usually expressed in dBFS.

**LSB (LEAST SIGNIFICANT BIT)** is the bit that has the smallest value or weight of all bits. This value is

$$\text{LSB} = V_{FS} / 2^n$$

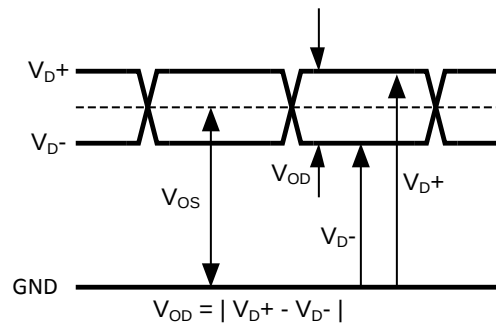
where

- $V_{FS}$  is the differential full-scale amplitude  $V_{IN}$  as set by the FSR input and "n" is the ADC resolution in bits, which is 8 for the ADC081000

(1)

**LVDS DIFFERENTIAL OUTPUT VOLTAGE ( $V_{OD}$ )** is this absolute value of the difference between the  $V_{D+}$  and  $V_{D-}$  outputs, each measured with respect to Ground.

**LVDS OUTPUT OFFSET VOLTAGE ( $V_{OS}$ )** is the midpoint between the the  $D+$  and  $D-$  pins' output voltages; i.e.,  $[(V_{D+}) + (V_{D-})] / 2$ .



**MISSING CODES** are those output codes that are skipped and will never appear at the ADC outputs. These codes cannot be reached with any input value.

**MSB (MOST SIGNIFICANT BIT)** is the bit that has the largest value or weight. Its value is one half of full scale.

**NEGATIVE FULL-SCALE ERROR** is a measure of how far the last code transition is from the ideal  $1/2$  LSB above a differential  $-V_{IN}/2$ . For the ADC081000 the reference voltage is assumed to be ideal, so this error is a combination of full-scale error and reference voltage error.

**OFFSET ERROR ( $V_{OFF}$ )** is a measure of how far the mid-scale point is from the ideal zero voltage differential input.

**OUTPUT DELAY ( $t_{OD}$ )** is the time delay after the falling edge of the DCLK before the data update is present at the output pins.

**OVER-RANGE RECOVERY TIME** is the time required after the differential input voltages goes from  $\pm 1.2V$  to  $0V$  for the converter to recover and make a conversion with its rated accuracy.

**PIPELINE DELAY (LATENCY)** is the number of clock cycles between initiation of conversion and when that data is presented to the output driver stage. New data is available at every clock cycle, but the data lags the conversion by the Pipeline Delay plus the  $t_{OD}$ .

**POSITIVE FULL-SCALE ERROR (PFSE)** is a measure of how far the last code transition is from the ideal  $1-1/2$  LSB below a differential  $+V_{IN}/2$ . For the ADC081000 the reference voltage is assumed to be ideal, so this error is a combination of full-scale error and reference voltage error.

**POWER SUPPLY REJECTION RATIO (PSRR)** can be one of two specifications. PSRR1 (DC PSRR) is the ratio of the change in offset error that results from a power supply voltage change from 1.8V to 2.0V. PSRR2 (AC PSRR) is a measure of how well an a.c. signal riding upon the power supply is rejected from the output and is measured with a 248 MHz, 50 mV<sub>P-P</sub> signal riding upon the power supply. It is the ratio of the output amplitude of that signal at the output to its amplitude on the power supply pin. PSRR is expressed in dB.

**SIGNAL TO NOISE RATIO (SNR)** is the ratio, expressed in dB, of the rms value of the input signal at the output to the rms value of the sum of all other spectral components below one-half the sampling frequency, not including harmonics or d.c.

**SIGNAL TO NOISE PLUS DISTORTION (S/(N+D) or SINAD)** is the ratio, expressed in dB, of the rms value of the input signal at the output to the rms value of all of the other spectral components below half the clock frequency, including harmonics but excluding d.c.

**SPURIOUS FREE DYNAMIC RANGE (SFDR)** is the difference, expressed in dB, between the rms values of the input signal at the output and the peak spurious signal, where a spurious signal is any signal present in the output spectrum that is not present at the input, excluding d.c.

**TOTAL HARMONIC DISTORTION (THD)** is the ratio expressed in dB, of the rms total of the first nine harmonic levels at the output to the level of the fundamental at the output. THD is calculated as

$$\text{THD} = 20 \times \log \sqrt{\frac{A_{f2}^2 + \dots + A_{f10}^2}{A_{f1}^2}}$$

where

- $A_{f1}$  is the RMS power of the fundamental (output) frequency
- $A_{f2}$  through  $A_{f10}$  are the RMS power of the first 9 harmonic frequencies in the output spectrum (2)
- **Second Harmonic Distortion (2nd Harm)** is the difference, expressed in dB, between the RMS power in the input frequency seen at the output and the power in its 2nd harmonic level at the output.
- **Third Harmonic Distortion (3rd Harm)** is the difference expressed in dB between the RMS power in the input frequency seen at the output and the power in its 3rd harmonic level at the output.

## Transfer Characteristic

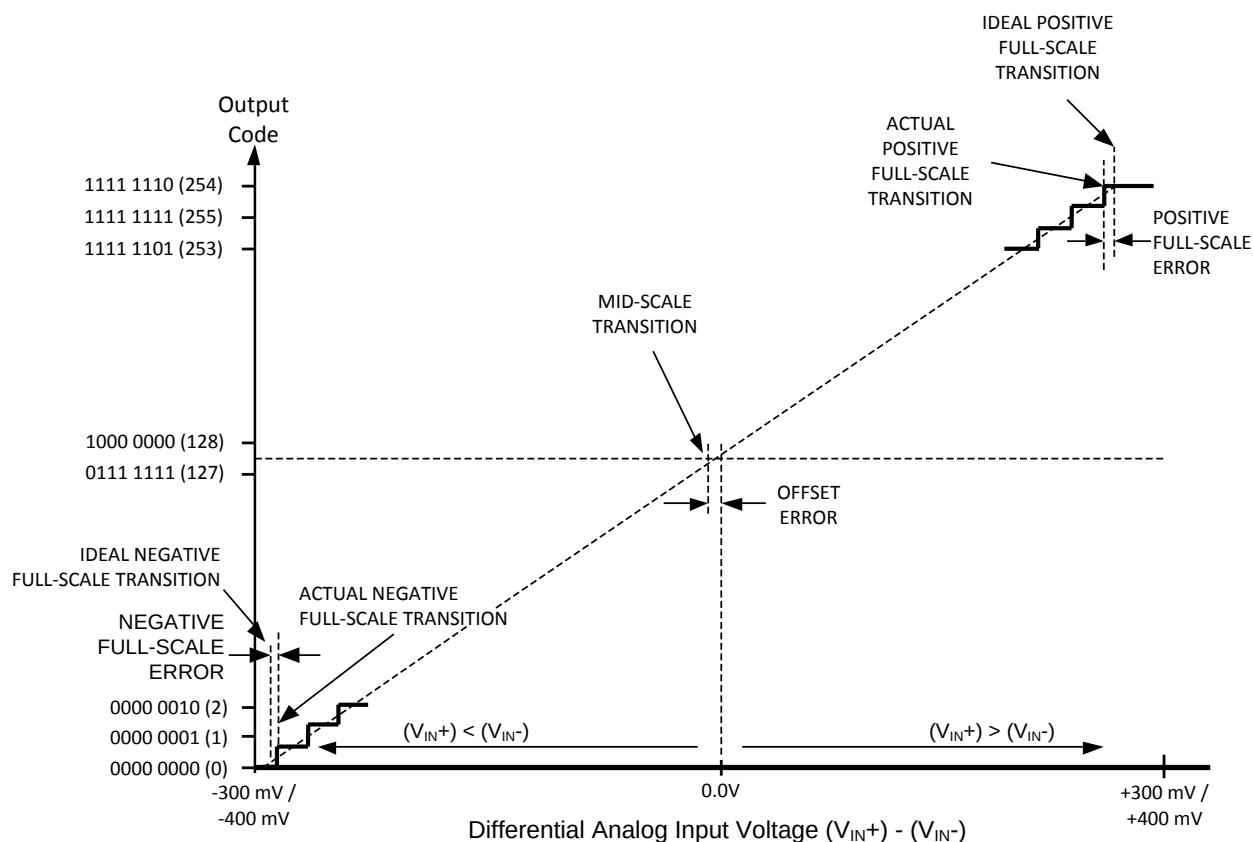


**Figure 2. Input / Output Transfer Characteristic**

## Timing Diagrams

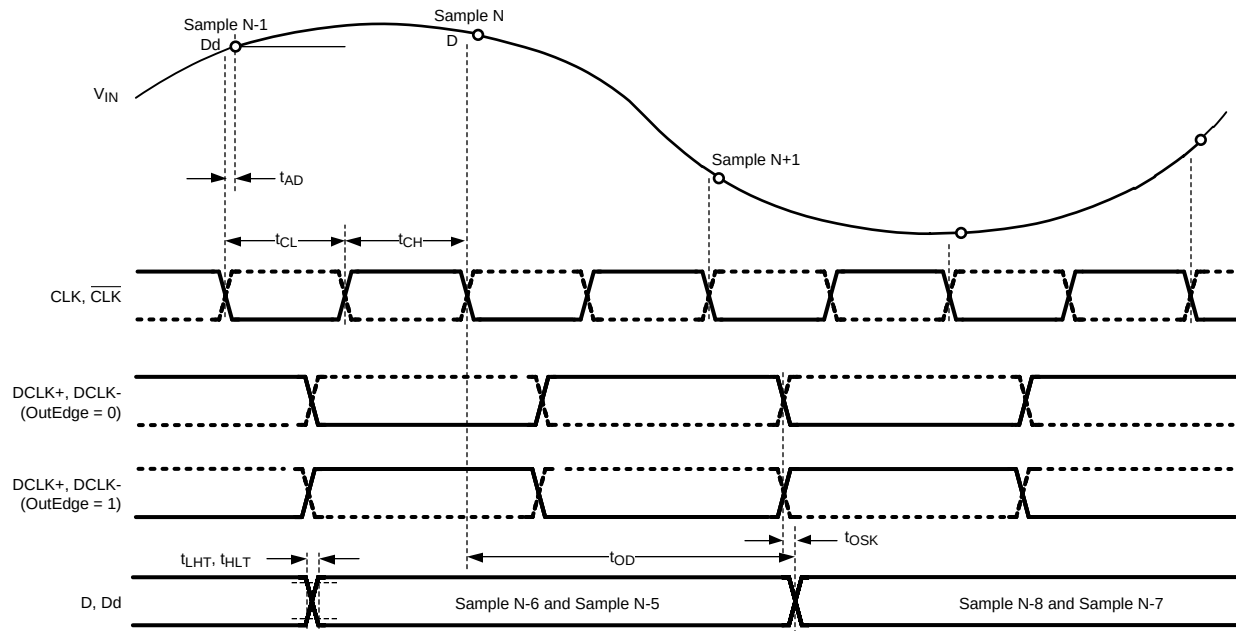


**Figure 3. ADC081000 Timing**

## TYPICAL PERFORMANCE CHARACTERISTICS

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

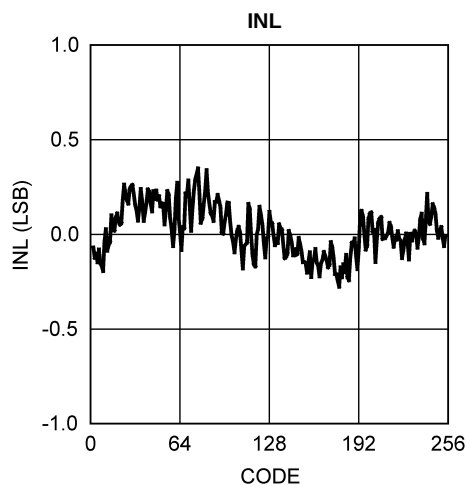


Figure 4.

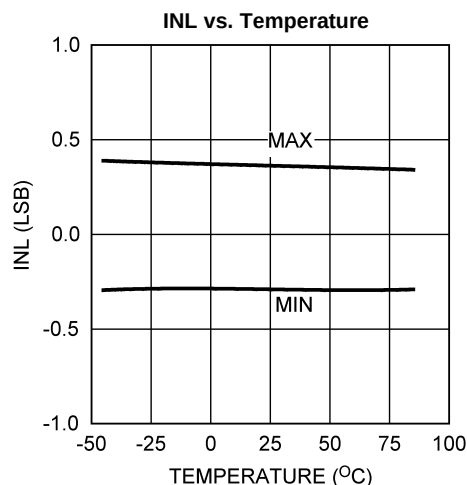


Figure 5.

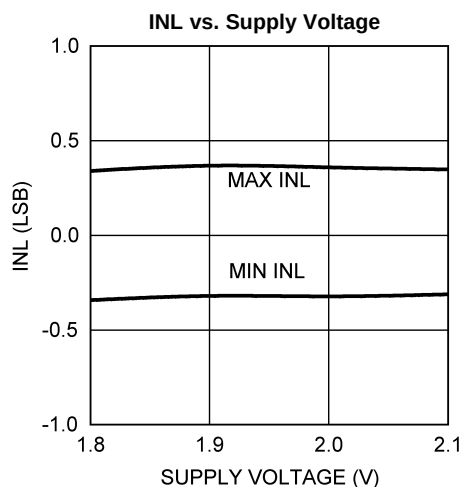


Figure 6.

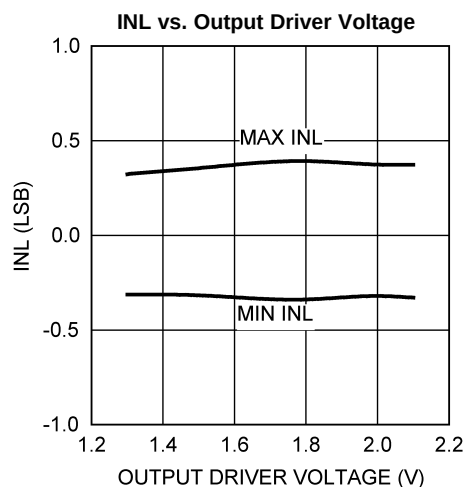


Figure 7.

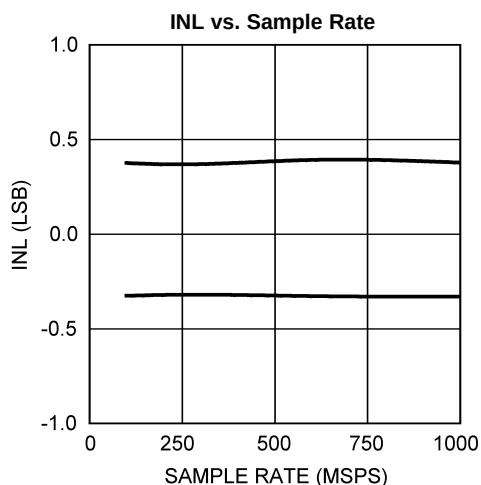


Figure .

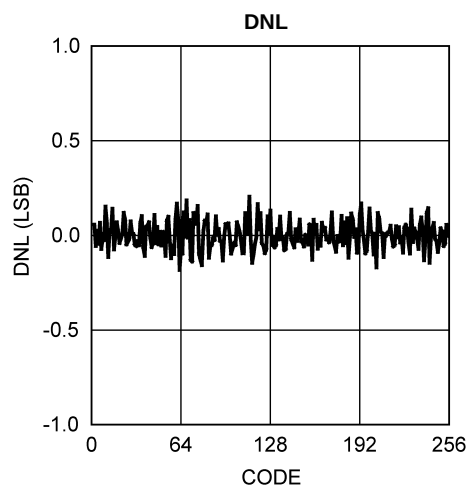


Figure 8.

## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

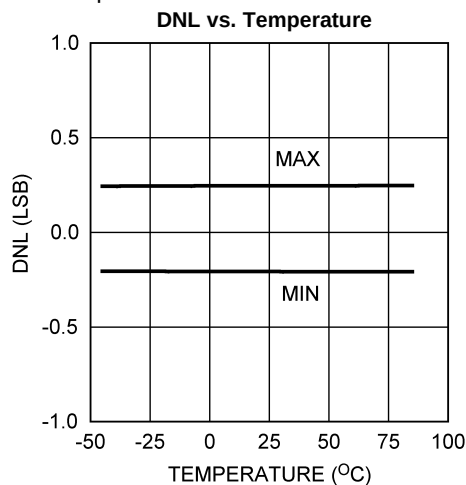


Figure 9.

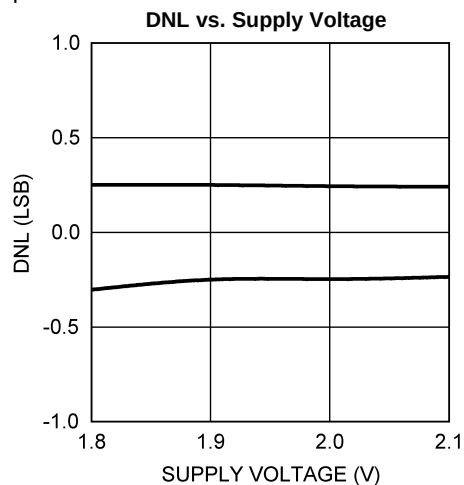


Figure 10.

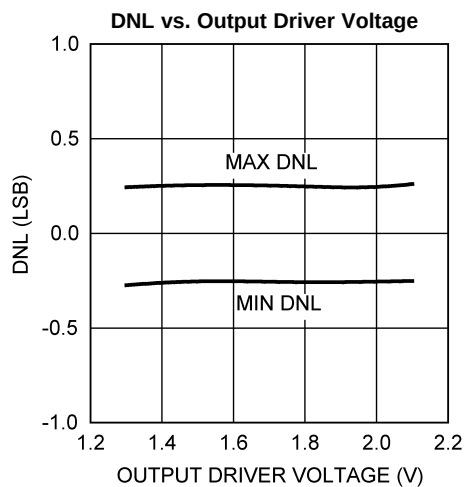


Figure 11.

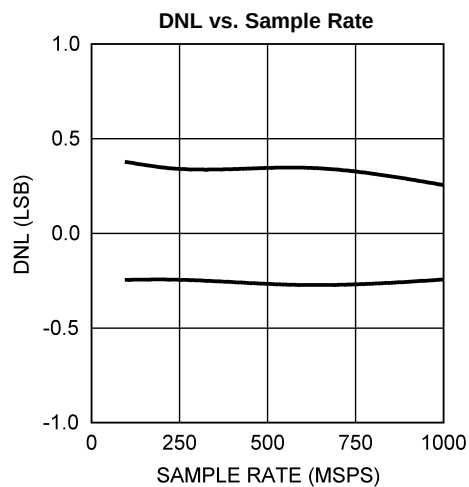


Figure 12.

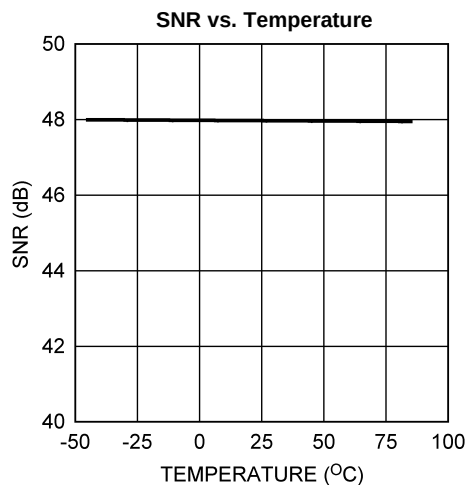


Figure 13.

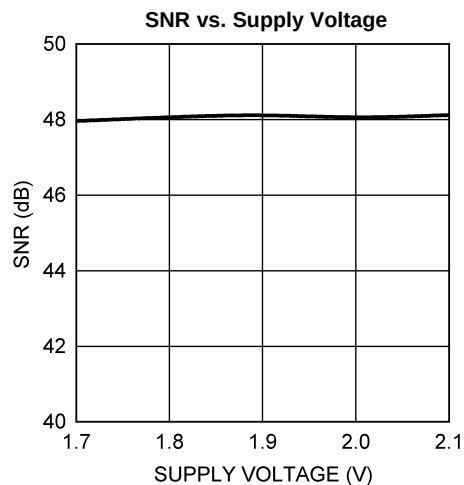


Figure 14.

### TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

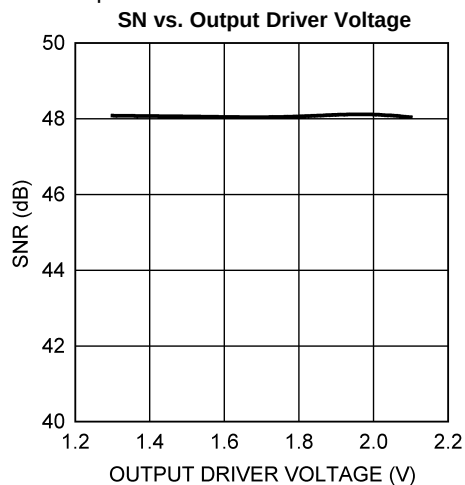


Figure 15.

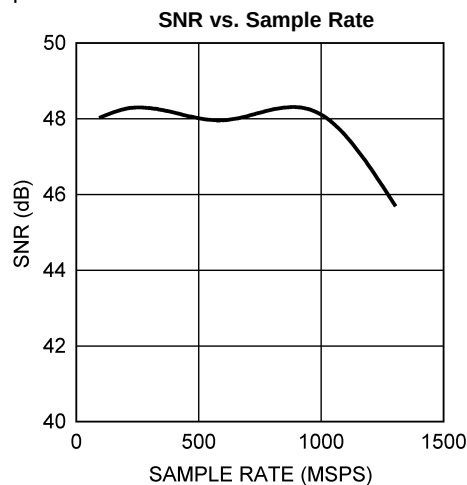


Figure 16.

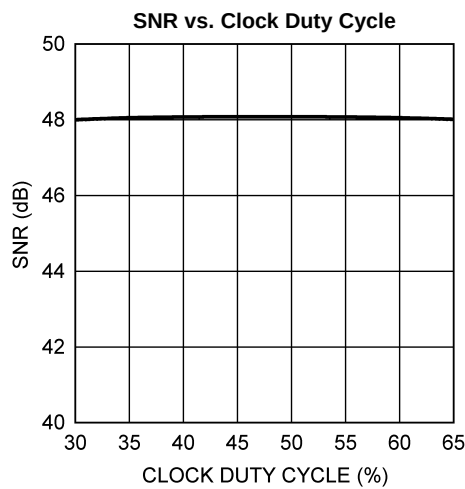


Figure 17.

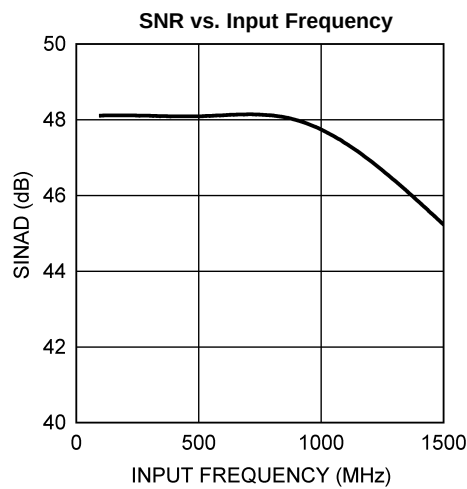


Figure 18.

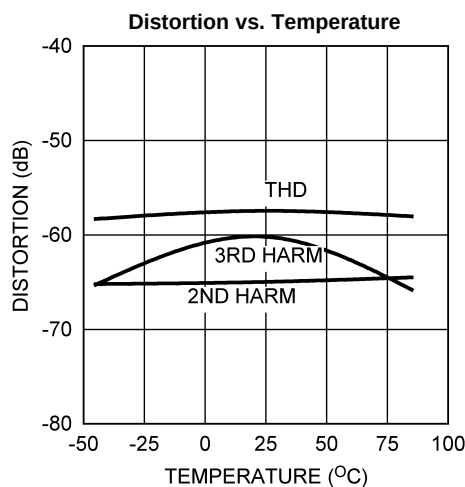


Figure 19.

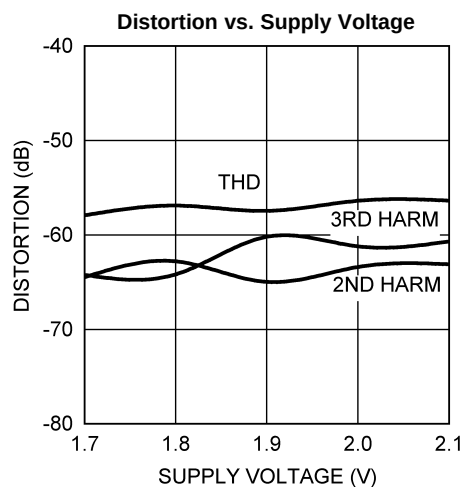


Figure 20.

## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

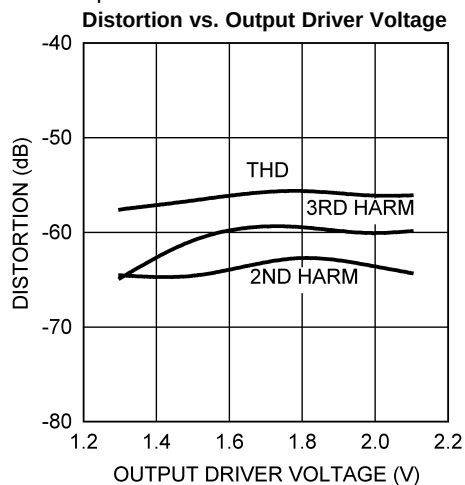


Figure 21.

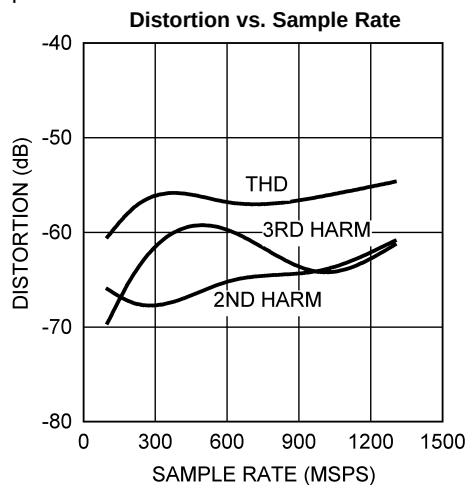


Figure 22.

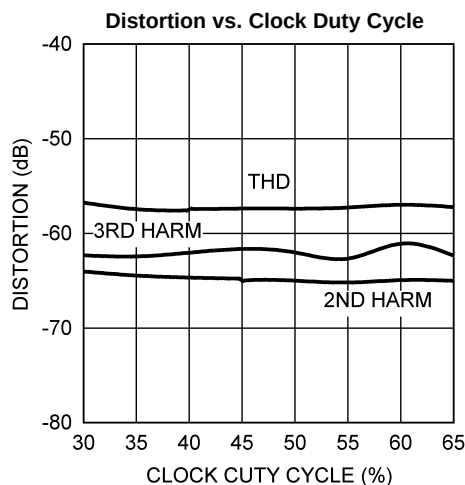


Figure 23.

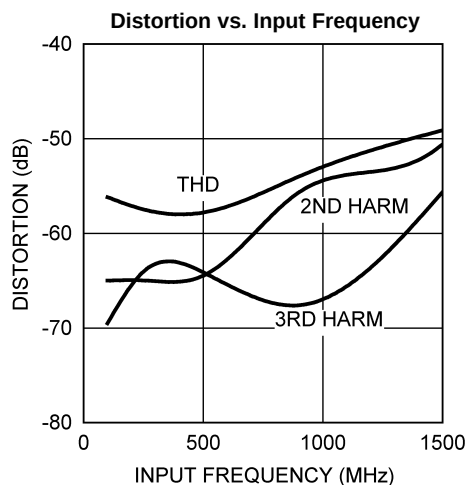


Figure 24.

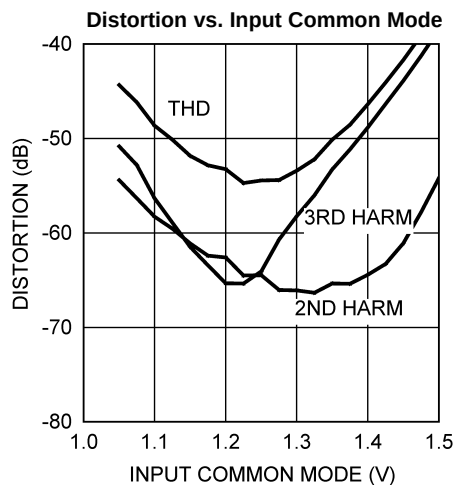


Figure 25.

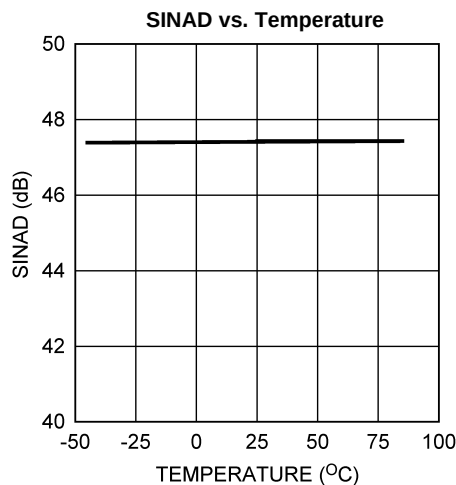


Figure 26.

## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

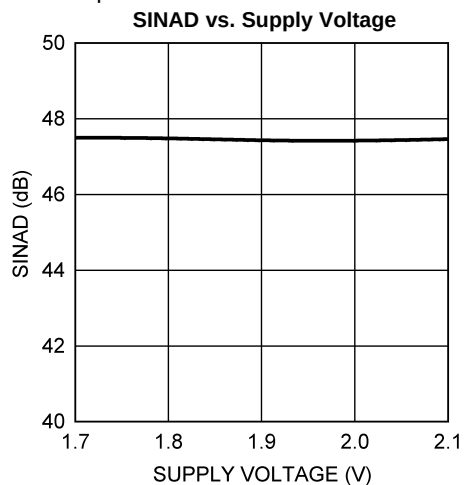


Figure 27.

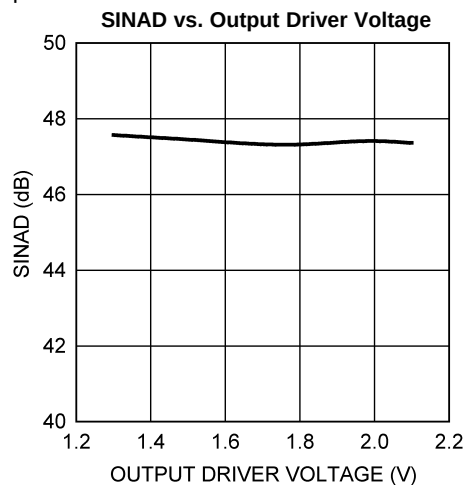


Figure 28.

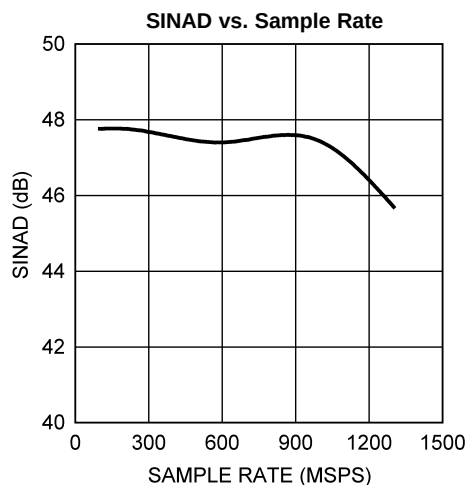


Figure 29.

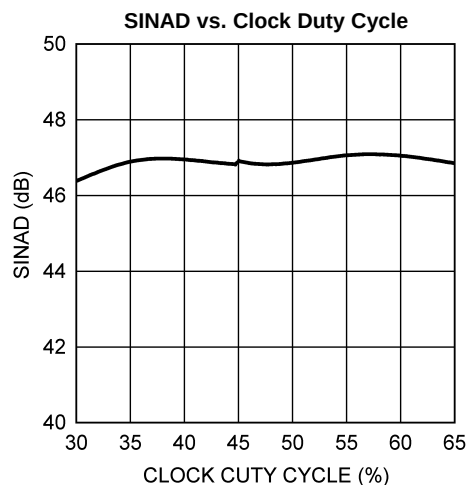


Figure 30.

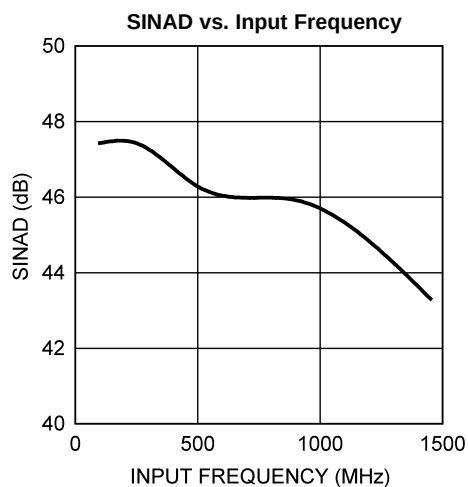


Figure 31.

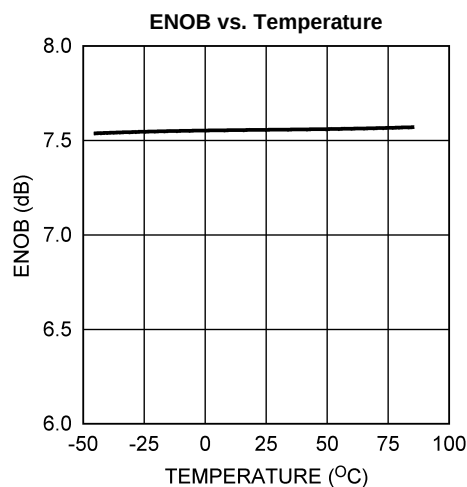


Figure 32.

## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

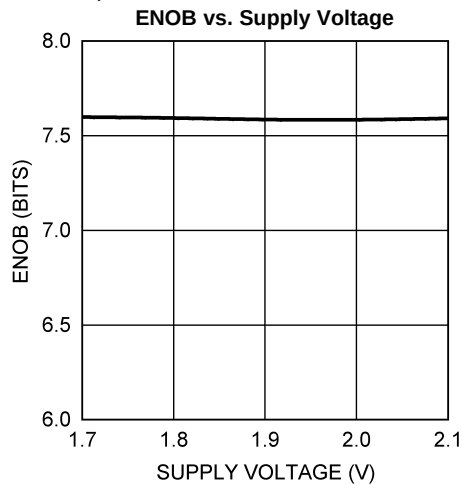


Figure 33.

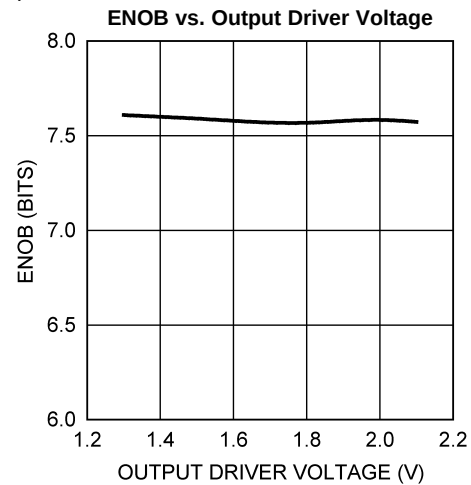


Figure 34.

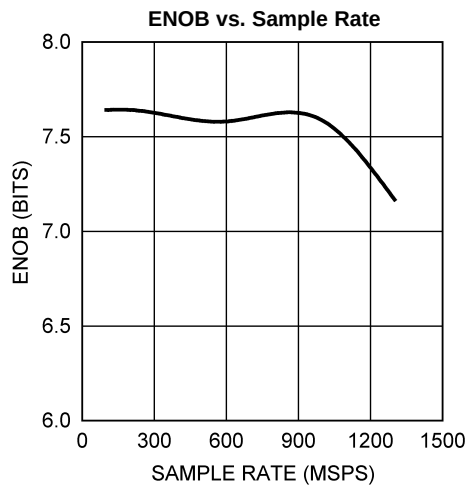


Figure 35.

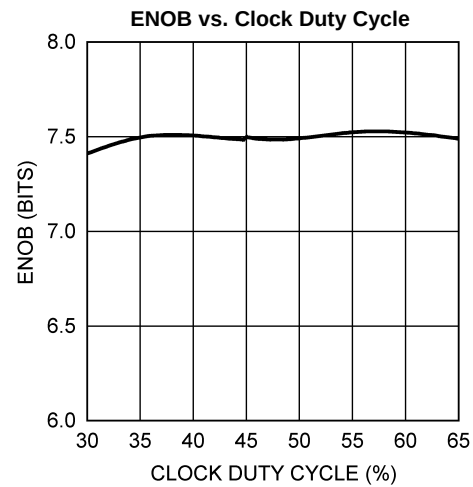


Figure 36.

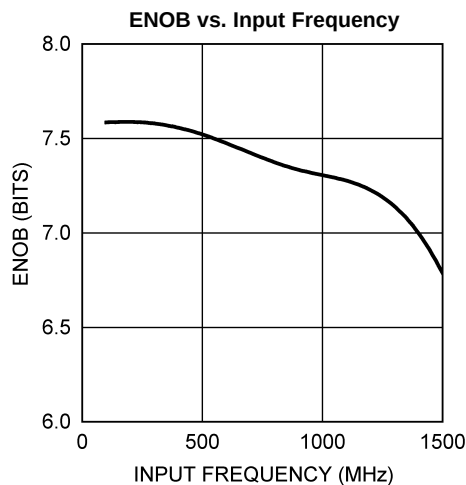


Figure 37.

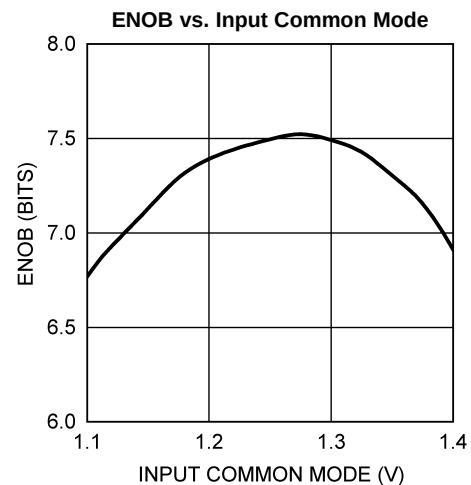


Figure 38.

### TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

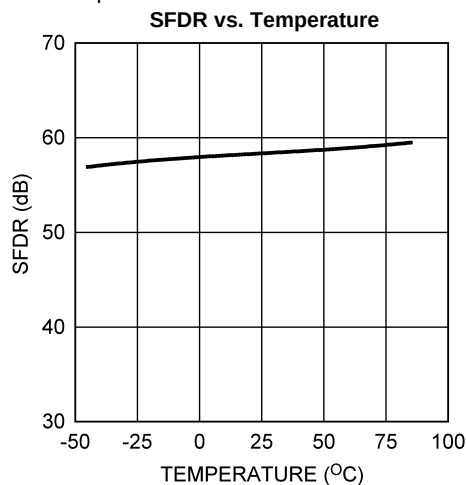


Figure 39.

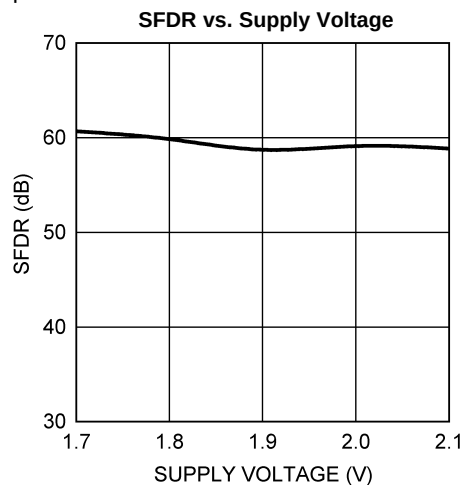


Figure 40.

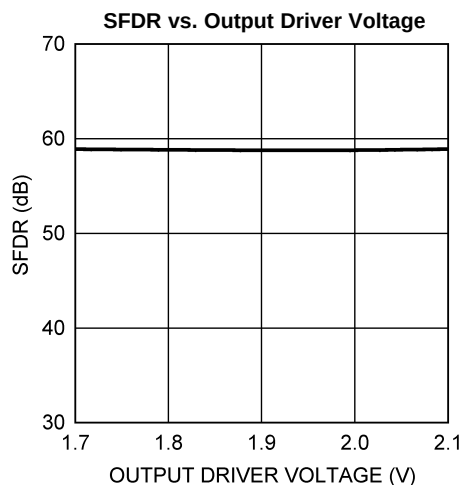


Figure 41.

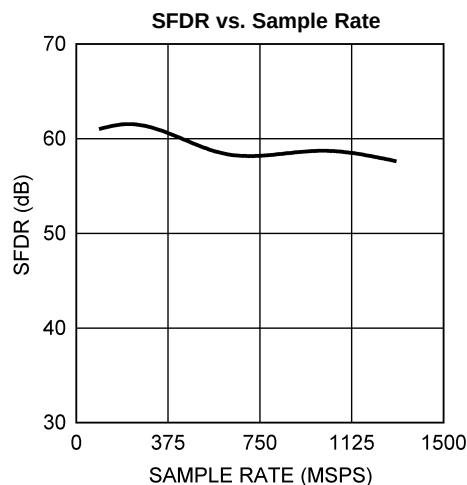


Figure 42.

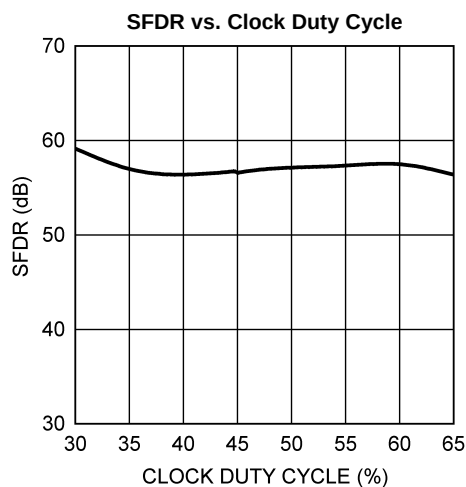


Figure 43.

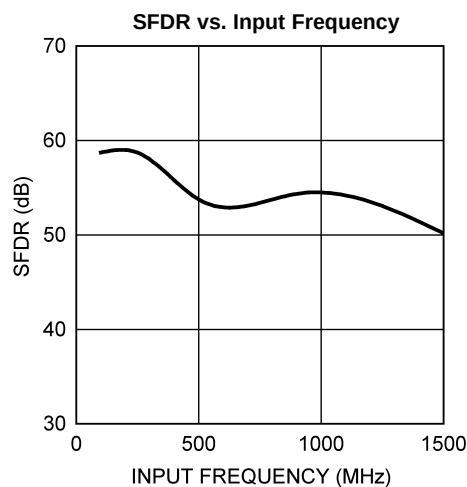


Figure 44.

## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

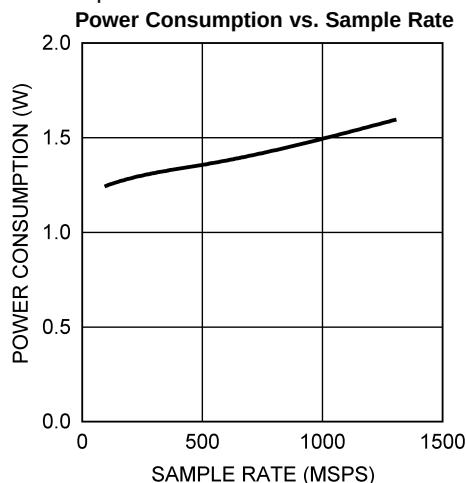


Figure 45.

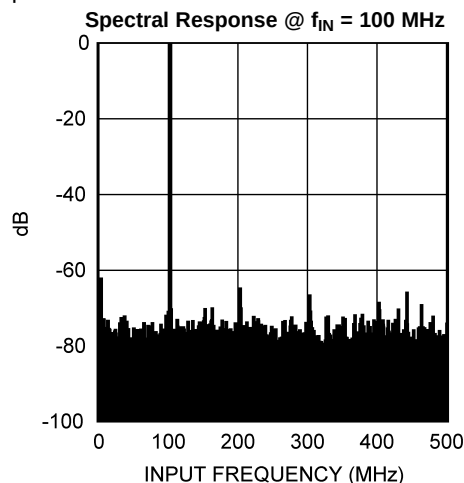


Figure 46.

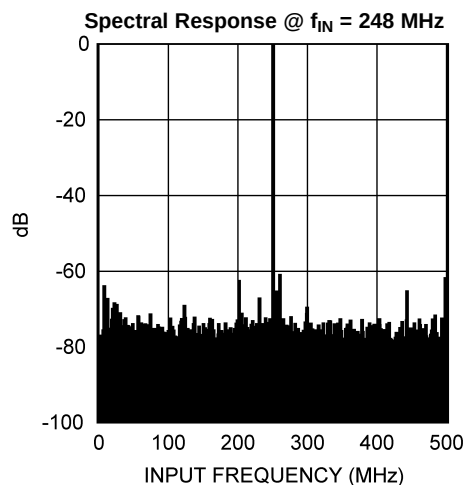


Figure 47.

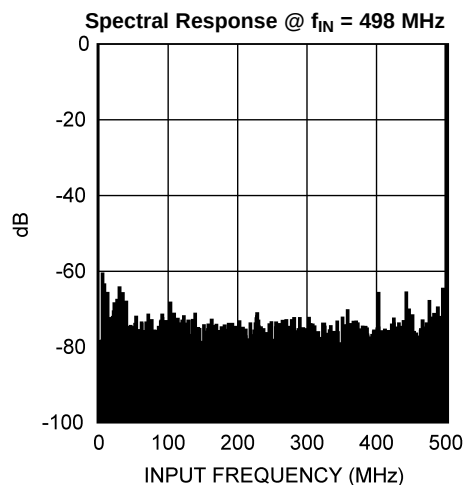


Figure 48.

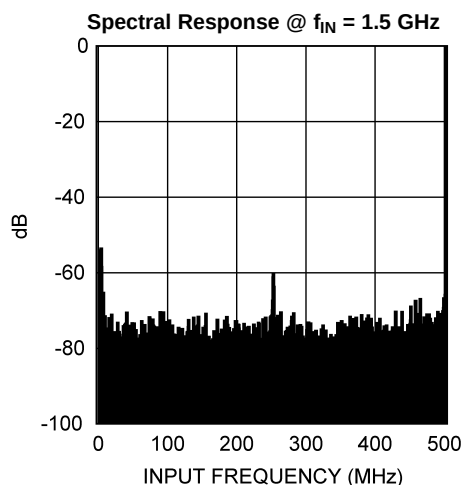


Figure 49.

### TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_A = V_{DR} = +1.9V$ ,  $f_{CLK} = 1\text{ GHz}$  (differential clock),  $f_{IN} = 248\text{ MHz}$ , Differential Inputs, unless otherwise stated. Parameters shown across temperature were measured after recalibration at each temperature.

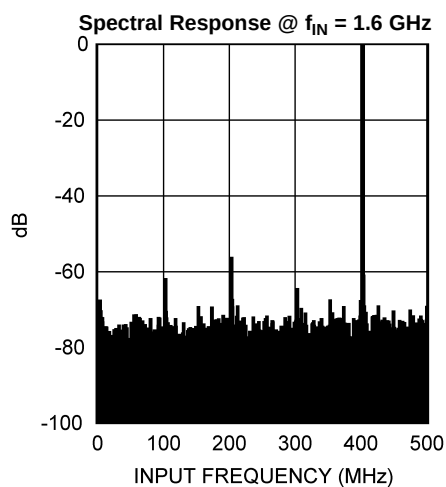


Figure 50.

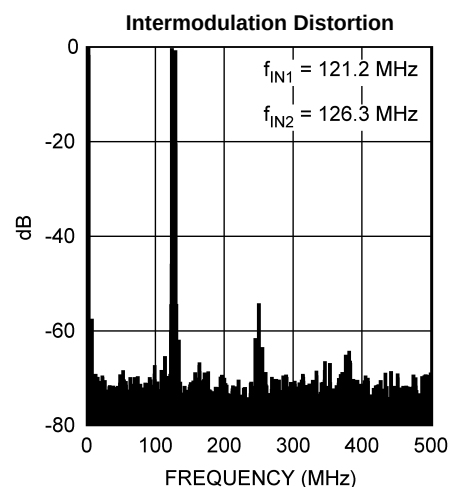


Figure 51.

## Functional Description

The ADC081000 is a versatile, high performance, easy to use A/D Converter with an innovative architecture permitting very high speed operation. The controls available ease the application of the device to circuit solutions. The ADC081000 uses a calibrated folding and interpolating architecture that achieves over 7.5 effective bits. The use of folding amplifiers greatly reduces the number of comparators and power consumption, while Interpolation reduces the number of front-end amplifiers required, minimizing the load on the input signal and further reducing power requirements. In addition to other things, on-chip calibration reduces the INL bow often seen with folding architectures. The result is an extremely fast, high performance, low power converter. Optimum performance requires adherence to the provisions discussed here and in the Applications Information Section.

## OVERVIEW

The analog input signal that is within the converter's input voltage range is digitized to eight bits at speeds of 200 MSPS to 1.6 GSPS, typical. Differential input voltages below negative full-scale will cause the output word to consist of all zeroes. Differential input voltages above positive full-scale will cause the output word to consist of all ones. The OR (Out of Range) output is activated whenever the correct output code would be outside of the 00h to FFh range.

The converter has a 1:2 demultiplexer that feeds two LVDS output buses. The data on these buses provide an output word rate on each bus at half the ADC sampling rate and must be interleaved by the user to provide output words at the full conversion rate.

The output levels may be selected to be normal or reduced. Using reduced levels saves power but could result in erroneous data capture of some or all of the bits, especially at higher sample rates and in marginally designed systems.

The voltage reference for the ADC081000 is derived from a 1.254V bandgap reference which is made available to the user at the  $V_{BG}$  pin. This output is capable of sourcing or sinking  $\pm 100 \mu A$ .

The internal bandgap derived reference voltage has a nominal value of 600 mV or 800 mV, as determined by the FSR pin and described in [The Analog Inputs](#). There is no provision for the use of an external reference voltage.

The fully differential comparator design and the innovative design of the sample-and-hold amplifier, together with self calibration, enables flat SINAD/ENOB response beyond 1.0 GHz. The ADC081000 output data signaling is LVDS and the output format is offset binary.

## Self-Calibration

A self-calibration is performed upon power-up and can also be invoked by the user upon command. Calibration trims the 100 $\Omega$  analog input differential termination resistor and minimizes full-scale error, offset error, DNL and INL, resulting in maximizing SNR, THD, SINAD (SNDR), SFDR and ENOB. Internal bias currents are also set with the calibration process. All of this is true whether the calibration is performed upon power up or is performed upon command.

Running the self calibration is important for this chip's functionality and is *required* in order to obtain adequate performance. In addition to the requirement to be run at power-up, self calibration must be re-run whenever the sense of the FSR pin is changed.

For best performance, we recommend that self calibration be run 20 seconds or more after application of power and whenever the operating ambient temperature changes more than 30°C since calibration was last performed. See [On-Command Calibration](#) for more information.

During the calibration process, the input termination resistor is trimmed to a value that is equal to  $R_{EXT} / 33$ . This external resistor must be placed between pin 32 and ground and must be 3300  $\Omega \pm 0.1\%$ . With this value, the input termination resistor is trimmed to be 100  $\Omega$ . Because  $R_{EXT}$  is also used to set the proper bias current for the Track and Hold amplifier, for the preamplifiers and for the comparators, other values of  $R_{EXT}$  should not be used.

In normal operation, calibration is performed just after application of power and whenever a valid calibration command is given, which is holding the CAL pin low for at least 10 clock cycles, then holding it high for at least another 10 clock cycles. There is no need to bring the CAL pin low after the 10 clock cycles of CAL high to begin the calibration routine. Holding the CAL pin high upon power up, however, will prevent the calibration process from running until the CAL pin experiences the above-mentioned 10 clock cycles low followed by 10 cycles high.

The CalDly pin is used to select one of two delay times after the application of power to the start of calibration. This calibration delay is  $2^{24}$  clock cycles (about 16.8 ms at 1 GSPS) with CalDly low, or  $2^{30}$  clock cycles (about 1.07 seconds at 1 GSPS) with CalDly high. These delay values allow the power supply to come up and stabilize before calibration takes place. If the PD pin is high upon power-up, the calibration delay counter will be disabled until the PD pin is brought low. Therefore, holding the PD pin high during power up will further delay the start of the power-up calibration cycle. The best setting of the CalDly pin depends upon the power-on settling time of the power supply.

The CalRun output is high whenever the calibration procedure is running. This is true whether the calibration is done at power-up or on-command.

Calibration can not be initiated or run while the device is in the power-down mode. See [Power Down](#) for information on the interaction between Power Down and Calibration.

## Acquiring the Input

Data is acquired at the falling edge of CLK+ (pin 18) and the digital equivalent of that data is available at the digital outputs 7 clock cycles later for the "D" output bus and 8 clock cycles later for the "Dd" output bus. There is an additional internal delay called  $t_{OD}$  before the data is available at the outputs. See the Timing Diagram. The ADC081000 will convert as long as the clock signal is present and the PD pin is low.

## The Analog Inputs

The ADC081000 must be driven with a differential input signal. It is important that the inputs either be a.c. coupled to the inputs with the DC\_Coup pin grounded or d.c. coupled with the DC\_Coup pin high and have an input common mode voltage that is equal to and tracks the  $V_{CMO}$  output.

Two full-scale range settings are provided with the FSR pin. A high on that pin causes an input differential full-scale range setting of 800 mV<sub>P-P</sub>, while grounding that pin causes an input differential full-scale range setting of 600 mV<sub>P-P</sub>.

## Clocking

The ADC081000 must be driven with an a.c. coupled, differential clock signal. [THE CLOCK INPUTS](#) describes the use of the clock input pins. A differential LVDS output clock is available for use in latching the ADC output data into whatever receives that data.

To help ease data capture, the output data may be caused to transition on either the positive or the negative edge of the output data clock (DCLK). This is chosen with the OutEdge input. A high on the OutEdge input causes the output data to transition on the rising edge of DCLK, while grounding this input causes the output to transition on the falling edge of DCLK.

## The LVDS Outputs

The data outputs, the Out Of Range (OR) and DCLK are LVDS compliant outputs. Output current sources provide 3 mA of output current to a differential 100 Ohm load when the OutV input is high or 2.2 mA when the OutV input is low. For short LVDS lines and low noise systems, satisfactory performance may be realized with the OutV input low, which results in lower power consumption. If the LVDS lines are long and/or the system in which the ADC081000 is used is noisy, it may be necessary to tie the OutV pin high.

Note that the LVDS levels are not intended to meet any given LVDS specification, but output levels are such that interfacing with LVDS receivers is practical.

## Out Of Range (OR) Indication

The input signal is out of range whenever the correct code would be above positive full-scale or below negative full scale. When the input signal for any given sample is thus out of range, the OR output is high for that word time.

## Power Down

The ADC081000 is in the active state when the Power Down pin (PD) is low. When the PD pin is high, the device is in the power down mode, where the device power consumption is reduced to a minimal level and the outputs are in a high impedance state. Upon return to normal operation, the pipeline will contain meaningless information and must be flushed.

If the PD input is brought high while a calibration is running, the device will not go into power down until the calibration sequence is complete. However, if power is applied and PD is already high, the device will not begin the calibration sequence until the PD input goes low. If a manual calibration is requested while the device is powered down, the calibration will not begin at all. That is, the manual calibration input is completely ignored in the power down state.

## Summary of Control Pins and Convenience Outputs

[Table 1](#) and [Table 2](#) are provided as a guide to the use of the various control and convenience pins of the ADC081000. Note that this table is only a guide and that the rest of this data sheet should be consulted for the full meaning and use of these pins.

**Table 1. Digital Control Pins**

| PIN | DESCRIPTION | LOW                                 | HIGH                                |
|-----|-------------|-------------------------------------|-------------------------------------|
| 3   | OutV        | 440mV Outputs                       | 600mV Outputs                       |
| 4   | OutEdge     | Data Transition at DCLK Fall        | Data Transition at DCLK Rise        |
| 14  | DC_Coup     | A.C. Coupled Inputs                 | D.C. Coupled Inputs                 |
| 26  | PD          | Normal Operation                    | Power Down                          |
| 30  | CAL         | Normal Operation                    | Run Calibration                     |
| 35  | FSR         | 600 mV <sub>P-P</sub> Full-Scale In | 800 mV <sub>P-P</sub> Full-Scale In |
| 127 | CalDly      | 2 <sup>24</sup> Clock Cycles        | 2 <sup>30</sup> Clock Cycles        |

**Table 2. Convenience Output Pins**

| PIN      | DESCRIPTION      | USE / INDICATION                                                |
|----------|------------------|-----------------------------------------------------------------|
| 7        | V <sub>CMO</sub> | Common Mode Output Voltage.                                     |
| 31       | V <sub>BG</sub>  | 1.25V Convenience Output.                                       |
| 79<br>80 | OR+<br>OR–       | Differential Out-Of-Range Indication; active high.              |
| 126      | CalRun           | Low is normal operation. High indicates Calibration is running. |

## APPLICATIONS INFORMATION

### THE REFERENCE VOLTAGE

The voltage reference for the ADC081000 is derived from a 1.254V bandgap reference which is made available at the  $V_{BG}$  output for user convenience and has an output current capability of  $\pm 100\ \mu\text{A}$ . The  $V_{BG}$  output should be buffered if more current than this is required of it.

The internal bandgap-derived reference voltage causes the full-scale peak-to-peak input swing to be either 600 mV or 800 mV, as determined by the FSR pin and described in [The Analog Inputs](#). There is no provision for the use of an external reference voltage.

### THE ANALOG INPUT

The analog input is a differential one to which the signal source may be a.c. coupled or d.c. coupled. [Table 3](#) gives the input to output relationship with the FSR pin high. With the FSR pin grounded, the millivolt values in [Table 3](#) are reduced to 75% of the values indicated.

The buffered analog inputs simplify the task of driving these inputs and the RC pole that is generally used at sampling ADC inputs is not required. If it is desired to use an amplifier circuit before the ADC, use care in choosing an amplifier with adequate noise and distortion performance and adequate gain at the frequencies used for the application.

**Table 3. DIFFERENTIAL INPUT TO OUTPUT RELATIONSHIP (FSR High)**

| $V_{IN+}$                 | $V_{IN-}$                 | Output Code           |
|---------------------------|---------------------------|-----------------------|
| $V_{CM} - 200\ \text{mV}$ | $V_{CM} + 200\ \text{mV}$ | 0000 0000             |
| $V_{CM} - 99\ \text{mV}$  | $V_{CM} + 99\ \text{mV}$  | 0100 0000             |
| $V_{CM}$                  | $V_{CM}$                  | 0111 1111 / 1000 0000 |
| $V_{CM} + 101\ \text{mV}$ | $V_{CM} - 101\ \text{mV}$ | 1100 0000             |
| $V_{CM} + 200\ \text{mV}$ | $V_{CM} - 200\ \text{mV}$ | 1111 1111             |

Note that a precise d.c. common mode voltage must be present at the ADC inputs. This common mode voltage,  $V_{CMO}$ , is provided on-chip when DC\_Coup (pin 14) is low and the input signal is a.c. coupled to the ADC. See [Figure 52](#).

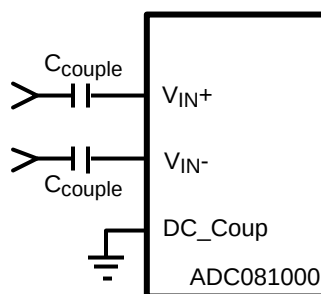


**Figure 52. Differential Input Drive**

When pin 14 is high, the analog inputs are d.c. coupled and a common mode voltage must be externally provided at the analog input pins. This common mode voltage should track the  $V_{CMO}$  output voltage. Note that the  $V_{CMO}$  output potential will change with temperature. The common mode output of the driving device should track this change. Full-scale distortion performance falls off rapidly as the input common mode voltage deviates from  $V_{CMO}$ . This is a direct result of using a very low supply voltage to minimize power. Keep the input common mode voltage within 50 mV of  $V_{CMO}$ .

Performance of the ADC081000 is as good in the d.c. coupled mode as it is in the a.c. coupled mode, provided the input common mode voltage at both analog input pins remain within 50 mV of  $V_{CMO}$ .

If d.c. coupling is used, it is best to servo the input common mode voltage, using the  $V_{CMO}$  pin, to maintain optimum performance.

Be sure that any current drawn from the  $V_{CMO}$  output does not exceed  $\pm 1 \mu A$ .

The Input impedance in the d.c. coupled mode (DC\_Coup pin high) consists of a precision 100 Ohm resistor between  $V_{IN+}$  and  $V_{IN-}$  and a capacitance from each of these inputs to ground. Driving the inputs beyond full scale will result in saturation or clipping of the reconstructed output.

### Handling Single-Ended Analog Signals

There is no provision for the ADC081000 to adequately process single-ended input signals. The best way to handle single-ended signals is to convert them to differential signals before presenting them to the ADC. The easiest way to accomplish single-ended to differential signal conversion is with an appropriate balun, as shown in Figure 53.

A balun is especially designed for very high frequencies and has a wider bandwidth than does a transformer so is preferred over a transformer for use with very high frequencies.

The ADC081000 is not designed to work with single-ended signals, so it is NOT RECOMMENDED that this be done. However, if the resulting drop in performance is allowable, drive the ADC081000 with a single-ended signal by bypassing the unused input to a.c. ground with a capacitor or connect it directly to the  $V_{CMO}$  pin. **DO NOT** connect either input pin directly to ground.

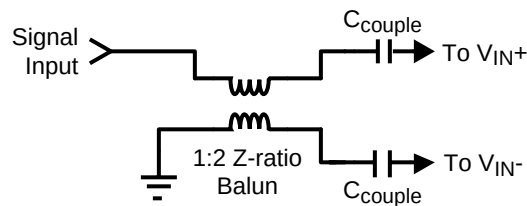


Figure 53. Single-Ended to Differential signal conversion with a balun

When d.c. coupling to the ADC081000 analog inputs is required, single-ended to differential conversion may be easily accomplished with the LMH6555, as shown in Figure 54. In such applications, the LMH6555 performs the task of single-ended to differential conversion while delivering low distortion and noise, as well as output balance, that supports the operation of the ADC081000. Connecting the ADC081000  $V_{CMO}$  pin to the  $V_{CM\_REF}$  pin of the LMH6555, through the appropriate buffer, will ensure that the ADC081000 common mode input voltage is as needed for optimum performance of the ADC081000. See Figure 54. The LMV321 was chosen as the buffer in Figure 54 for its low voltage operation and reasonable offset voltage. Be sure to limit output current from the ADC081000  $V_{CMO}$  pin to  $1.0 \mu A$ .

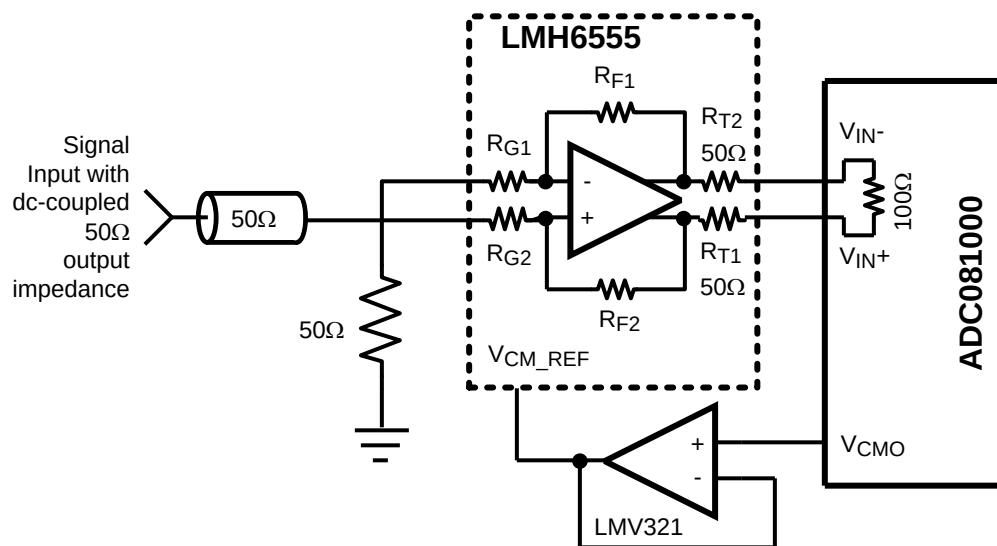


Figure 54. Example of Servoing the Analog Input with  $V_{CMO}$

## Out Of Range (OR) Indication

When the conversion result is clipped the Out of Range output is activated such that OR+ goes high and OR- goes low. This output is active as long as accurate data on either or both of the buses would be outside the range of 00h to FFh.

## Full-Scale Input Range

As with all A/D Converters, the input range is determined by the value of the ADC's reference voltage. The reference voltage of the ADC081000 is derived from an internal bandgap reference. The FSR pin controls the effective reference voltage of the ADC081000 such that the differential full-scale input range at the analog inputs is 800 mV<sub>P-P</sub> with the FSR pin high, or is 600 mV<sub>P-P</sub> with FSR pin low. Best SNR is obtained with FSR high, but better distortion and SFDR are obtained with the FSR pin low. The LMH6555 is suitable for both settings.

## THE CLOCK INPUTS

The ADC081000 has differential LVDS clock inputs, CLK+ and CLK-, which must be driven with an a.c. coupled, differential clock signal. Although the ADC081000 is tested and its performance is ensured with a differential 1.0-GHz clock, it typically will function well with clock frequencies indicated in the Electrical Characteristics Table. The clock inputs are internally terminated and biased. The clock signal must be capacitive coupled to the clock pins as indicated in [Figure 55](#).

Operation up to the sample rates indicated in the Electrical Characteristics Table is typically possible if the conditions of the Operating Ratings are not exceeded. Operating at higher sample rates than indicated for the given ambient temperature may result in reduced device reliability and product lifetime. This is because of the higher power consumption and die temperatures at high sample rates. Important also for reliability is proper thermal management. See [Thermal Management](#).

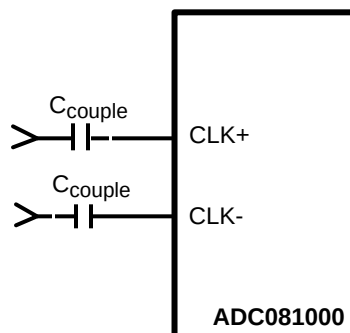


**Figure 55. Differential (LVDS) Clock Connection**

The differential Clock line pair should have a characteristic impedance of 100Ω and be terminated at the clock source in that (100Ω) characteristic impedance. The clock line should be as short and as direct as possible. The ADC081000 clock input is internally terminated with an untrimmed 100Ω resistor.

Insufficient clock levels will result in poor dynamic performance. Excessively high clock levels could cause a change in the analog input offset voltage. To avoid these problems, keep the clock level within the range specified in the Operating Ratings.

While it is specified and performance is ensured at 1.0 GSPS with a 50% clock duty cycle, ADC081000 performance is essentially independent of clock duty cycle. However, to ensure performance over temperature, it is recommended that the input clock duty cycle be such that the minimum clock high and low times are maintained within the range specified in the Electrical Characteristics Table.

High speed, high performance ADCs such as the ADC081000 require very stable clock signals with minimum phase noise or jitter. ADC jitter requirements are defined by the ADC resolution (number of bits), maximum ADC input frequency and the input signal amplitude relative to the ADC input full scale range. The maximum jitter (the total of the jitter from all sources) allowed to prevent a jitter-induced reduction in SNR is found to be

$$t_{J(MAX)} = (V_{INFSR} / V_{IN(P-P)}) \times (1/(2^{(N+1)} \times \pi \times f_{IN}))$$

where

- $t_{J(MAX)}$  is the rms total of all jitter sources in seconds
- $V_{IN(P-P)}$  is the peak-to-peak analog input signal
- $V_{INFSR}$  is the full-scale range of the ADC
- "N" is the ADC resolution in bits and  $f_{IN}$  is the maximum input frequency, in Hertz, to the ADC analog input (3)

Note that the maximum jitter described above is the rms total of the jitter from all sources, including that in the ADC clock, that added by the system to the ADC clock and input signals and that added by the ADC itself. Since the effective jitter added by the ADC is beyond user control, the best the user can do is to keep the sum of the externally added clock jitter and the jitter added by the analog circuitry to the analog signal to a minimum.

## CONTROL PINS

Seven control pins provide a wide range of possibilities in the operation of the ADC081000 and facilitate its use. These control pins provide Full-Scale Input Range setting, Self Calibration, Calibration Delay, Output Edge Synchronization choice, LVDS Output Level choice and a Power Down feature.

### Self Calibration

The ADC081000 self-calibration must be run to achieve rated performance. This procedure is performed upon power-up and can be run any time on command. The calibration procedure is exactly the same whether there is a clock present upon power up or if the clock begins some time after application of power. The CalRun output indicator is high while a calibration is in progress.

### Power-on Calibration

Power-on calibration begins after a time delay following the application of power. This time delay is determined by the setting of CalDly, as described in [Self-Calibration](#).

The calibration process will not be performed if the CAL pin is high at power up. In this case, the calibration cycle will not begin until on-command calibration conditions are met. The ADC081000 will function with the CAL pin held high at power up, but no calibration will be done and performance will be impaired. A manual calibration, however, may be performed after powering up with the CAL pin high. See [On-Command Calibration](#).

The internal power-on calibration circuitry comes up in a random state. If the clock is not running at power up and the power on calibration circuitry is active, it will hold the analog circuitry in power down and the power consumption will typically be less than 200 mW. The power consumption will be normal after the clock starts.

### On-Command Calibration

Calibration may be run at any time by bringing the CAL pin high for a minimum of 10 clock cycles after it has been low for a minimum of 10 clock cycles. Holding the CAL pin high upon power up will prevent execution of power-on calibration until the CAL pin is low for a minimum of 10 clock cycles, then brought high for a minimum of another 10 clock cycles. The calibration cycle will begin 10 clock cycles after the CAL pin is thus brought high.

The minimum 10 clock cycle sequences are required to ensure that random noise does not cause a calibration to begin when it is not desired. As mentioned in [Self-Calibration](#), for best performance, a self calibration should be performed 20 seconds or more after power up and repeated when the ambient temperature changes more than 30°C since the last self calibration was run. SINAD drops about 1.5 dB for every 30°C change in die temperature and ENOB drops about 0.25 bit for every 30°C change in die temperature.

### Calibration Delay

The CalDly input (pin 127) is used to select one of two delay times after the application of power to the start of calibration, as described in [Self-Calibration](#). The calibration delay values allow the power supply to come up and stabilize before calibration takes place. With no delay or insufficient delay, calibration would begin before the power supply is stabilized at its operating value and result in non-optimal calibration coefficients. If the PD pin is high upon power-up, the calibration delay counter will be disabled until the PD pin is brought low. Therefore, holding the PD pin high during power up will further delay the start of the power-up calibration cycle. The best setting of the CalDly pin depends upon the power-on settling time of the power supply.

## Output Edge Synchronization

DCLK signals are available to help latch the converter output data into external circuitry. The output data can be synchronized with either edge of these clock signals. That is, the output data transition can be set to occur with either the rising edge or the falling edge of the DCLK signal, so that either edge of that clock signal can be used to latch the output data into the receiving circuit.

When the OutEdge pin is high, the output data is synchronized with (changes with) the rising edge of DCLK+. When OutEdge is low, the output data is synchronized with the falling edge of DCLK+.

At the very high speeds of which the ADC081000 is capable, slight differences in the lengths of the clock and data lines can mean the difference between successful and erroneous data capture. The OutEdge pin is used to capture data on the DCLK edge that best suits the application circuit and layout.

## Power Down Feature

The Power Down (PD) pin, when high, puts the ADC081000 into a low power mode where power consumption is greatly reduced.

The digital output pins retain the last conversion output code when the clock is stopped, but are in a high impedance state when the PD pin is high. However, upon return to normal operation (re-establishment of the clock and/or lowering of the PD pin), the pipeline will contain meaningless information and must be flushed.

If the PD input is brought high while a calibration is running, the device will not go into power down until the calibration sequence is complete. However, if power is applied and PD is already high, the device will not begin the calibration sequence until the PD input goes low. If a manual calibration is requested while the device is powered down, the calibration will not begin at all. That is, the manual calibration input is completely ignored in the power down state.

## THE DIGITAL OUTPUTS

The ADC081000 demultiplexes its output data onto two LVDS output buses.

The results of successive conversions started on the odd falling edges of the CLK+ pin are available on one of the two LVDS buses, while the results of conversions started on the even falling edges of the CLK+ pin are available on the other LVDS bus. This means that the word rate at each LVDS bus is 1/2 the ADC081000 clock rate and the two buses must be interleaved to obtain the entire 1 GSPS conversion result.

Since the minimum recommended clock rate for this device is 200 MSPS, the effective sample rate can be reduced to as low as 100 MSPS by using the results available on just one of the two LVDS buses and a 200 MHz input clock, decimating the 200 MSPS data by two.

There is one LVDS clock pair available for use to latch the LVDS outputs on both buses. Whether the data is sent at the rising or falling edge of DCLK+ is determined by the sense of the OutEdge pin, as described in [Output Edge Synchronization](#).

The OutV pin is used to set the LVDS differential output levels. See [The LVDS Outputs](#).

The output format is Offset Binary. Accordingly, a full-scale input level with  $V_{IN+}$  positive with respect to  $V_{IN-}$  will produce an output code of all ones, a full-scale input level with  $V_{IN-}$  positive with respect to  $V_{IN+}$  will produce an output code of all zeros and when  $V_{IN+}$  and  $V_{IN-}$  are equal, the output code will vary between 127 and 128.

## POWER CONSIDERATIONS

A/D converters draw sufficient transient current to corrupt their own power supplies if not adequately bypassed. A 33  $\mu$ F capacitor should be placed within an inch (2.5 cm) of the A/D converter power pins. A 0.1  $\mu$ F capacitor should be placed as close as possible to each  $V_A$  pin, preferably within one-half centimeter. Leadless chip capacitors are preferred because they have low lead inductance. Having power and ground planes in adjacent layers of the PC Board will provide the best supply bypass capacitance in terms of low ESL.

The  $V_A$  and  $V_{DR}$  supply pins should be isolated from each other to prevent any digital noise from being coupled into the analog portions of the ADC. A ferrite choke, such as the JW Miller FB20009-3B, is recommended between these supply lines when a common source is used for them.

As is the case with all high speed converters, the ADC081000 should be assumed to have little power supply noise rejection. Any power supply used for digital circuitry in a system where a lot of digital power is being consumed should not be used to supply power to the ADC081000. The ADC supplies should be the same supply used for other analog circuitry, if not a dedicated supply.

### Supply Voltage

The ADC081000 is specified to operate with a supply voltage of  $1.9V \pm 0.1V$ . It is very important to note that, while this device will function with slightly higher supply voltages, these higher supply voltages may reduce product lifetime.

No pin should ever have a voltage on it that is in excess of the supply voltage or below ground by more than 150 mV, not even on a transient basis. This can be a problem upon application of power and power shut-down. Be sure that the supplies to circuits driving any of the input pins, analog or digital, do not come up any faster than does the voltage at the ADC081000 power pins.

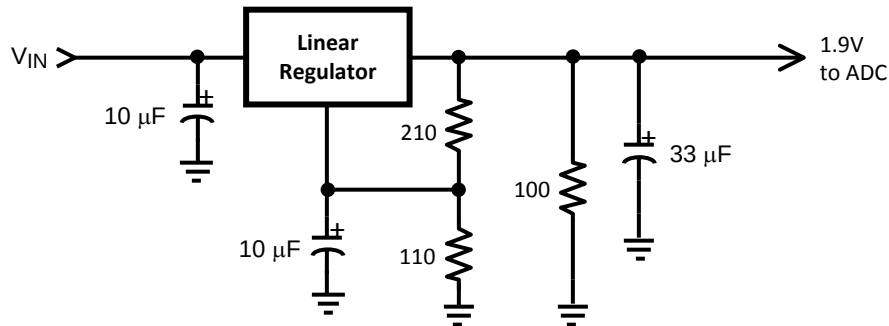


Figure 56. Non-Spiking Power Supply

The Absolute Maximum Ratings should be strictly observed, even during power up and power down. A power supply that produces a voltage spike at turn-on and/or turn-off of power can destroy the ADC081000. The circuit of Figure 56 will provide supply overshoot protection.

Many linear regulators will produce output spiking at power-on unless there is a minimum load provided. Active devices draw very little current until their supply voltages reach a few hundred millivolts. The result can be a turn-on spike that can destroy the ADC081000, unless a minimum load is provided for the supply. The 100Ω resistor at the regulator output in Figure 56 provides a minimum output current during power-up to ensure there is no turn-on spiking.

In this circuit, an LM317 linear regulator is satisfactory if its input supply voltage is 4V to 5V . If a 3.3V supply is used, an LM1086 linear regulator is recommended. Also, be sure that the impedance of the power distribution system is low to minimize resistive losses and minimize noise on the power supply.

The output drivers should have a supply voltage,  $V_{DR}$ , that is within the range specified in the Operating Ratings table. This voltage should not exceed the  $V_A$  supply voltage and should never spike to a voltage greater than ( $V_A + 100mV$ ).

If the power is applied to the device without a clock signal present, the current drawn by the device might be below 100 mA. This is because the ADC081000 gets reset through clocked logic and its initial state is random. If the reset logic comes up in the "on" state, it will cause most of the analog circuitry to be powered down, resulting in less than 100 mA of current draw. This current is greater than the power down current because not all of the ADC is powered down. The device current will be normal after the clock is established.

### Thermal Management

The ADC081000 is capable of impressive speeds and performance at very low power levels for its speed. However, the power consumption is still high enough to require attention to thermal management. For reliability reasons, the die temperature should be kept to a maximum of 130°C. That is,  $t_A$  (ambient temperature) plus ADC power consumption times  $\theta_{JA}$  (junction to ambient thermal resistance) should not exceed 130°C. This is not a problem if the ambient temperature is kept to a maximum of +85°C, the device is soldered to a PC Board and the sample rate is at or below 1 Gsps.

Note that the following are general recommendations for mounting exposed pad devices onto a PCB. This should be considered the starting point in PCB and assembly process development. It is recommended that the process be developed based upon past experience in package mounting.

The package of the ADC081000 has an exposed pad on its back that provides the primary heat removal path as well as excellent electrical grounding to the printed circuit board. The land pattern design for lead attachment to the PCB should be the same as for a conventional LQFP, but the exposed pad must be attached to the board to remove the maximum amount of heat from the package, as well as to ensure best product parametric performance.

To maximize the removal of heat from the package, a thermal land pattern must be incorporated on the PCB within the footprint of the package. The exposed pad of the device must be soldered down to ensure adequate heat conduction out of the package. The land pattern for this exposed pad should be at least as large as the 5 x 5 mm of the exposed pad of the package and be located such that the exposed pad of the device is entirely over that thermal land pattern. This thermal land pattern should be electrically connected to ground. A clearance of at least 0.5 mm should separate this land pattern from the mounting pads for the package pins.

Since a large aperture opening may result in poor release, the aperture opening should be subdivided into an array of smaller openings, similar to the land pattern of [Figure 57](#).

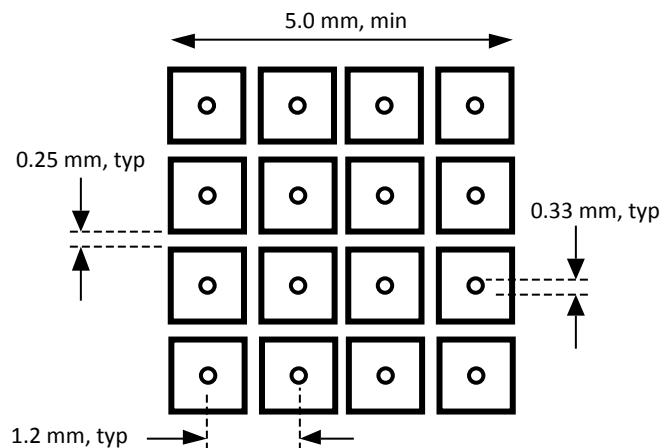


**Figure 57. Recommended Package Land Pattern**

To minimize junction temperature, it is recommended that a simple heat sink be built into the PCB. This is done by including a minimum copper pad of 2 inches by 2 inches (5.1 cm by 5.1 cm) on the opposite side of the PCB. This copper area may be plated or solder coated to prevent corrosion, but should not have a conformal coating, which could provide some thermal insulation. Thermal vias should be used to connect these top and bottom copper areas. These thermal vias act as "heat pipes" to carry the thermal energy from the device side of the board to the opposite side of the board where it can be more effectively dissipated. The use of 9 to 16 thermal vias is recommended.

The thermal vias should be placed on a 1.2 mm grid spacing and have a diameter of 0.30 to 0.33 mm. These vias should be barrel plated to avoid solder wicking into the vias during the soldering process as this wicking could cause voids in the solder between the package exposed pad and the thermal land on the PCB. Such voids could increase the thermal resistance between the device and the thermal land on the board, which would cause the device to run hotter.

On a board of FR-4 material and the built in heat sink described above (4 square inch pad and 9 thermal vias), the die temperature stabilizes at about 30°C above the ambient temperature in about 20 seconds.

If it is desired to monitor die temperature, a temperature sensor may be mounted on the heat sink area of the board near the thermal vias. Allow for a thermal gradient between the temperature sensor and the ADC081000 die of  $\theta_{JC}$  times typical power consumption =  $2.8 \times 1.43 = 4^\circ\text{C}$ . Allowing for a  $5^\circ\text{C}$  (including an extra  $1^\circ\text{C}$ ) temperature drop from the die to the temperature sensor, then, would mean that maintaining a maximum pad temperature reading of  $125^\circ\text{C}$  will ensure that the die temperature does not exceed  $130^\circ\text{C}$ , assuming that the exposed pad of the ADC081000 is properly soldered down and the thermal vias are adequate.

## LAYOUT AND GROUNDING

Proper grounding and proper routing of all signals are essential to ensure accurate conversion. A single ground plane should be used, as opposed to splitting the ground plane into analog and digital areas.

Since digital switching transients are composed largely of high frequency components, the skin effect tells us that total ground plane copper weight will have little effect upon the logic-generated noise. Total surface area is more important than is total ground plane volume. Coupling between the typically noisy digital circuitry and the sensitive analog circuitry can lead to poor performance that may seem impossible to isolate and remedy. The solution is to keep the analog circuitry well separated from the digital circuitry.

High power digital components should not be located on or near any linear component or power supply trace or plane that services analog or mixed signal components as the resulting common return current path could cause fluctuation in the analog input “ground” return of the ADC, causing excessive noise in the conversion result.

Generally, we assume that analog and digital lines should cross each other at  $90^\circ$  to avoid getting digital noise into the analog path. In high frequency systems, however, avoid crossing analog and digital lines altogether. Clock lines should be isolated from ALL other lines, analog AND digital. The generally accepted  $90^\circ$  crossing should be avoided as even a little coupling can cause problems at high frequencies. Best performance at high frequencies is obtained with a straight signal path.

The analog input should be isolated from noisy signal traces to avoid coupling of spurious signals into the input. This is especially important with the low level drive required of the ADC081000. Any external component (e.g., a filter capacitor) connected between the converter's input and ground should be connected to a very clean point in the analog ground plane. All analog circuitry (input amplifiers, filters, etc.) should be separated from any digital components.

## DYNAMIC PERFORMANCE

The ADC081000 is a.c. tested and its dynamic performance is ensured. To meet the published specifications and avoid jitter-induced noise, the clock source driving the CLK input must exhibit low rms jitter. The allowable jitter is a function of the input frequency and the input signal level, as described in [THE CLOCK INPUTS](#).

It is good practice to keep the ADC clock line as short as possible, to keep it well away from any other signals and to treat it as a transmission line. Other signals can introduce jitter into the clock signal. The clock signal can also introduce noise into the analog path if not isolated from that path.

Best dynamic performance is obtained when the exposed pad at the back of the package has a good connection to ground. This is because this path from the die to ground is a lower impedance than that offered by the package pins.

## COMMON APPLICATION PITFALLS

**Allowing loose power supply voltage tolerance.** The ADC081000 is specified for operation between 1.8 Volts to 2.0 Volts. Using a 1.8 Volt power supply then implies the need for no negative tolerance. The best solution is to use an adjustable linear regulator such as the LM317 or LM1086 set for 1.9V as discussed in [Supply Voltage](#).

**Driving the inputs (analog or digital) beyond the power supply rails.** For device reliability, all inputs should not go more than 150 mV below the ground pins or 150 mV above the supply pins. Exceeding these limits on even a transient basis may not only cause faulty or erratic operation, but may impair device reliability. It is not uncommon for high speed digital circuits to exhibit undershoot that goes more than a volt below ground. Controlling the impedance of high speed lines and terminating these lines in their characteristic impedance should control overshoot.

Care should be taken not to overdrive the inputs of the ADC081000. Such practice may lead to conversion inaccuracies and even to device damage.

**Incorrect analog input common mode voltage in the d.c. coupled mode.** As discussed in [The Analog Inputs](#) and [THE ANALOG INPUT](#), the Input common mode voltage must remain within 50 mV of the  $V_{CMO}$  output and track that output, which has a variability with temperature that must also be tracked. Distortion performance will be degraded if the input common mode voltage is more than 50 mV from  $V_{CMO}$ .

**Using an inadequate amplifier to drive the analog input.** Use care when choosing a high frequency amplifier to drive the ADC081000 as many high speed amplifiers will have higher distortion than will the ADC081000, resulting in overall system performance degradation.

**Driving the  $V_{BG}$  pin to change the reference voltage.** As mentioned in [The Analog Inputs](#), the reference voltage is intended to be fixed to provide one of two different full-scale values (600 mV<sub>P-P</sub> and 800 mV<sub>P-P</sub>). Over driving this pin will not change the full scale value, but can otherwise upset operation.

**Driving the clock input with an excessively high level signal.** The ADC clock level should not exceed the level described in the Operating Ratings Table or the input offset error could increase.

**Inadequate clock levels.** As described in [THE CLOCK INPUTS](#), insufficient clock levels can result in poor performance. Excessive clock levels could result in the introduction of an input offset.

**Using an excessively long clock signal trace, or having other signals coupled to the clock signal trace.** This will cause the sampling interval to vary, causing excessive output noise and a reduction in SNR performance.

**Failure to provide adequate heat removal.** As described in [Thermal Management](#), it is important to provide an adequate heat removal to ensure device reliability. This can either be done with adequate air flow or the use of a simple heat sink built into the board. The backside pad should be grounded for best performance.

## REVISION HISTORY

### Changes from Revision F (May 2013) to Revision G

### Page

- Changed layout of National Data Sheet to TI format ..... [36](#)

## PACKAGING INFORMATION

| Orderable part number              | Status<br>(1) | Material type<br>(2) | Package   Pins    | Package qty   Carrier  | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|------------------------------------|---------------|----------------------|-------------------|------------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">ADC081000CIYB/NOPB</a> | Active        | Production           | HLQFP (NNB)   128 | 60   JEDEC TRAY (10+1) | Yes         | SN                                   | Level-3-260C-168 HR               | -40 to 85    | ADC081000<br>CIYB   |
| ADC081000CIYB/NOPB.A               | Active        | Production           | HLQFP (NNB)   128 | 60   JEDEC TRAY (10+1) | Yes         | SN                                   | Level-3-260C-168 HR               | -40 to 85    | ADC081000<br>CIYB   |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

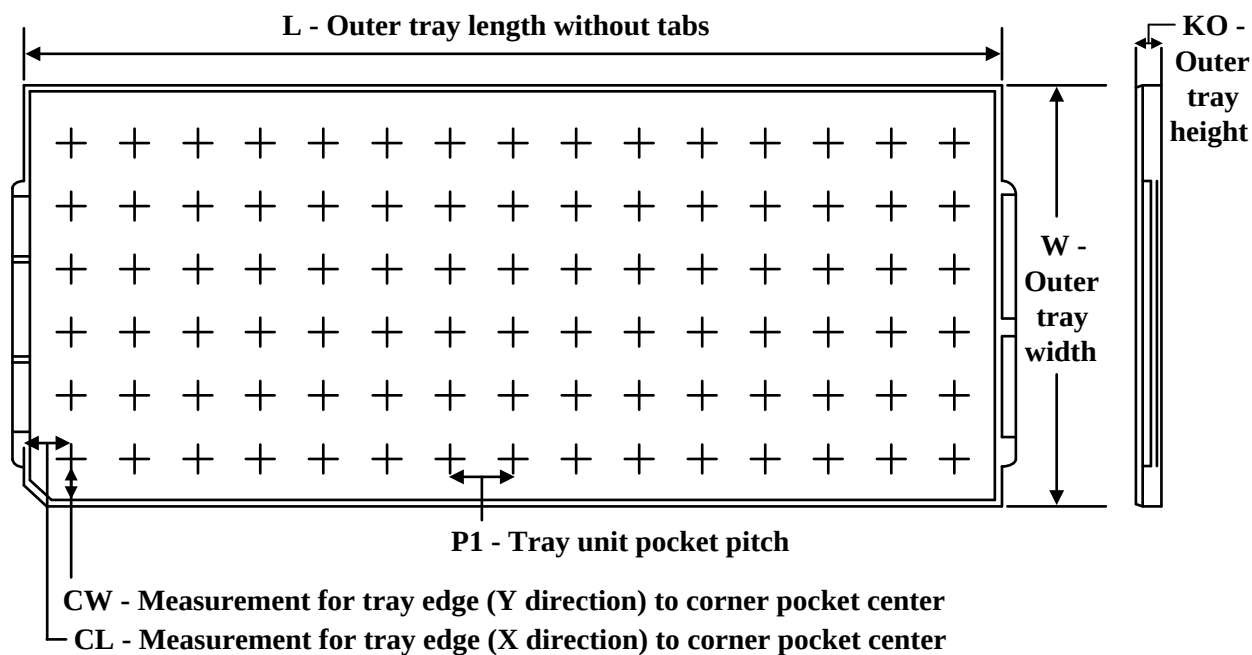
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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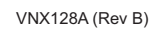
## TRAY



Chamfer on Tray corner indicates Pin 1 orientation of packed units.

\*All dimensions are nominal

| Device               | Package Name | Package Type | Pins | SPQ | Unit array matrix | Max temperature (°C) | L (mm) | W (mm) | K0 (μm) | P1 (mm) | CL (mm) | CW (mm) |
|----------------------|--------------|--------------|------|-----|-------------------|----------------------|--------|--------|---------|---------|---------|---------|
| ADC081000CIYB/NOPB   | NNB          | HLQFP        | 128  | 60  | 5 X 12            | 150                  | 322.6  | 135.9  | 7620    | 25.4    | 17.8    | 17.55   |
| ADC081000CIYB/NOPB.A | NNB          | HLQFP        | 128  | 60  | 5 X 12            | 150                  | 322.6  | 135.9  | 7620    | 25.4    | 17.8    | 17.55   |



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